

TPS6602x Integrated Source and Sink Power Multiplexer with VBUS LDO Regulator

1 Features

- Integrated 30 mΩ (typical), 32-V tolerant NFET 5-V source path, up to 3 A
- Integrated 22 mΩ (typical), 32-V tolerant NFET 4-V to 22-V sink path, up to 5 A
- Selectable current limit for 5-V source path
- Built-in soft-start to limit in-rush currents
- Integrated high voltage VBUS LDO regulator (3.3-V or 5.0-V per device type)
- Optional VBUS overvoltage protection via pin configuration.
- System supply and VBUS undervoltage protection
- 5-V System supply overvoltage protection
- Overtemperature protection
- Reverse-current protection
- Fault pin with de-glitched fault reporting
- Support for fast role swap
- IEC/UL Certificate No. US-34369-UL
 - Standards: IEC 62368-1 Ed. 2, UL 2367 Ed. 1
- Small footprint WCSP packaging, no HDI required.

2 Applications

- [Desktop PC/motherboard](#)
- [Standard notebook PC](#)
- [Chromebook and WOA](#)
- [Docking station](#)
- [Port/cable adapters and dongles](#)

3 Description

The TPS6602x is a full-featured power switch multiplexer that contains an integrated 5-V Source power path and a 4-V to 22-V Sink power path. The 5-V Source path limits the output current to a safe level by operating in a constant-current mode when the output load exceeds the selected current-limit threshold. Each power path supports overtemperature and reverse current protection. VBUS has overvoltage protection with its level being set by an optional external resistor divider. If no overvoltage protection is desired, it may be disabled by grounding the OVP terminal. The TPS6602x series supports a fault pin that indicates overcurrent and overtemperature events.

TPS6602x series also supports a high voltage VBUS LDO regulator (3.3-V or 5-V per device type) useful for supplying power to the device and other system components when operating in dead battery conditions. The TPS66020 regulates to 3.3-V and the TPS66021 regulates to 5-V.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPS66020	WCSP (28)	1.606 mm x 2.806 mm
TPS66021		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Function Table

EN1	EN0	Device State
0	0	Source and Sink paths disabled
0	1	Sink path enabled
1	0	Source path enabled, 1.5 A
1	1	Source path enabled, 3.0 A

TPS6602x Block Diagram

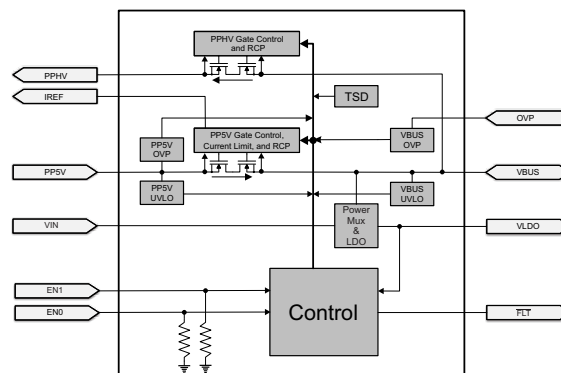


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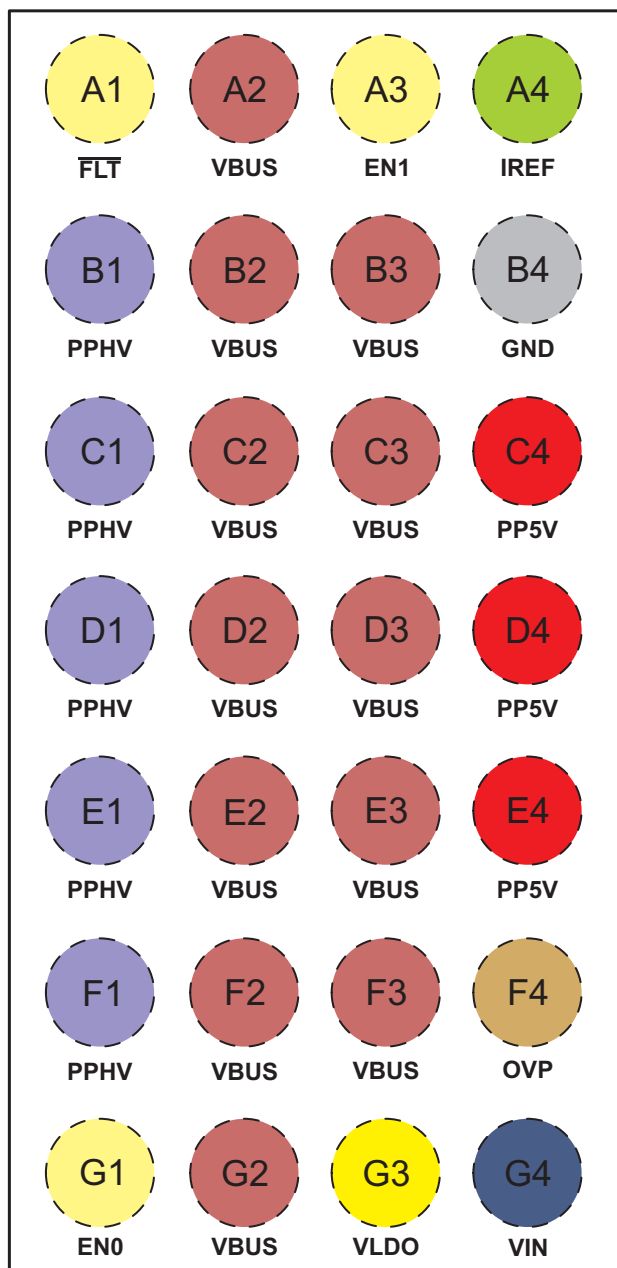
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4 Revision History

Changes from Revision A (September 2019) to Revision B	Page
• Changed from Advance Information to Production Data	1
Changes from Original (August 2019) to Revision A	Page
• Updated Applications section with links	1
• Added Typical Characteristics section	11
• Added Application Curves section	35

5 Pin Configuration and Functions

TPS6602x YBG Package
28-Pin WCSP
Top View



Pin Functions

Pin		I/O	Reset State	Description
Name	No.			
PP5V	C4, D4, E4	Power	Off	5-V System Supply to VBUS. Bypass with capacitance CPP5V to GND.
PPHV	B1, C1, D1, E1, F1	Power	Off	HV System Supply from VBUS. Bypass with capacitance CPPHV to GND.

Pin Functions (continued)

Pin		I/O	Reset State	Description
Name	No.			
VBUS	A2, B2, B3, C2, C3, D2, D3, E2, E3, F2, F3, G2	Power	-	5-V to 20-V nominal input supply to PPHV or 5-V output supply from PP5V. Bypass with capacitance CVBUS to GND.
VIN	G4	Power	-	Device input supply. Bypass with capacitance CVIN to GND.
VLDO	G3	Power	-	VIN supply or VBUS LDO regulated supply output from power multiplexer. Bypass with capacitance CVLDO to GND.
GND	B4	Ground	-	Ground. Connect all pins to ground plane.
OVP	F4	Analog	-	Selects VBUS OVP. Tie pin to VBUS resistor divider output to set desired VBUS OVP level. Tie pin to GND to remove VBUS OVP function.
EN1	A3	Digital Input	Pull-down	Enable control signal for PPHV Sink and PP5V Source paths. Internal pull-down.
EN0	G1	Digital Input	Pull-down	Enable control signal for PPHV Sink and PP5V Source paths. Internal pull-down.
IREF	A4	Analog		Used to set the PP5V source path current limit bias using an external resistor tied to GND.
$\overline{\text{FLT}}$	A1	Digital Output	Hi-Z	Fault Output Indicator. Active low. This pin is a true open-drain (no PMOS). Float pin when unused.

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

PARAMETER		MIN	MAX	UNIT
Terminal voltage range ⁽²⁾	PP5V, EN0 ⁽³⁾ , EN1 ⁽³⁾ , $\overline{\text{FLT}}$, VIN, VLDO	−0.3	6.2	V
Terminal voltage range ⁽²⁾	OVP	−0.3	VBUS	V
Terminal voltage range ⁽²⁾	VBUS, power path disabled (stand off voltage)	−0.5	32	V
Terminal voltage range ⁽²⁾	VBUS, power path enabled ⁽⁴⁾	−0.5	26	V
Terminal voltage range ⁽²⁾	PPHV	−0.3	26	V
Terminal voltage range ⁽²⁾	IREF	−0.3	4.5	V
Terminal positive source current	IREF	Internally limited		mA
Terminal positive source current	VLDO sourced from VBUS VLDO	Internally limited		mA
	VLDO sourced from VIN	50		mA
Storage temperature		−55	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to network GND. All GND pins must be connected directly to the GND plane of the board.
- (3) EN0 and EN1 each have an internal voltage clamp and may be driven above the absolute maximum voltage rating up to EN_CLAMP maximum specification if current is limited to less than 100μA.
- (4) For VBUS, a TVS protection with a break down voltage falling between the Recommended and Absolute maximum ratings is recommended, such as the TVS2200.

6.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±1000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{VIN}	Input voltage range ⁽¹⁾	VIN, TPS66020 only.	2.85	3.6	V
		VIN, TPS66021 only.	4.5	5.5	V
V _{PP5V}	Input voltage range ⁽¹⁾	PP5V	4.9	5.5	V
V _{PPHV}	Output voltage range ⁽¹⁾	PPHV	0	22	V
V _{VBUS}	Output voltage range ⁽¹⁾	VBUS when sourcing	0	5.5	V
V _{VBUS}	Input voltage range ⁽¹⁾	VBUS when sinking	4	22	V
V _{EN}	Input voltage range ⁽¹⁾	EN0, EN1	0	5.5	V
V _{FLT}	Output voltage range ⁽¹⁾	FLT	0	5.5	V
I _{O_PP5V}	Continuous current from PP5V to VBUS	T _J = 105°C		3	A
I _{O_PPHV}	Continuous current from VBUS to PPHV	T _J = 105°C		4	A
		T _J = 100°C		5	A
I _{O_VLDO}	Output current from VBUS LDO			30	mA
R _{IREF}	External resistor current limit reference	75kΩ ±1% overall tolerance	74.25	75.75	kΩ
T _J	Operating junction temperature		–10	125	°C
RR_PP5V	Maximum ramp rate on PP5V input supply		–2	2	V/μs
RR_PPHV	Maximum ramp rate on PPHV input supply		–2	2	V/μs
RR_VBUS	Maximum ramp rate on VBUS input supply		–2	2	V/μs
RR_VIN	Maximum ramp rate on VIN input supply			30	mV/μs

(1) All voltage values are with respect to network GND. GND pin must be connected directly to the ground plane of the board.

6.4 Recommended Supply Load Capacitance

over operating free-air temperature range (unless otherwise noted)

PARAMETER ⁽¹⁾		MIN	TYP	MAX	UNIT
CVIN	Capacitance on VIN	1			μF
CVLDO	Capacitance on VLDO	2.5	4.7	10	μF
CVBUS	Capacitance on VBUS	1		10	μF
CPP5V	Capacitance on PP5V	2.5	4.7		μF
CPPHV	Capacitance present on PPHV ⁽²⁾	1	47	100	μF

(1) Capacitance values do not include any derating factors. For example, if 5.0 μF is required and the external capacitor value reduces by 50% at the required operating voltage, then the required external capacitor value would be 10 μF.

(2) This capacitance represents the system side load capacitance that may be seen by the device e.g. from a typical battery charging system. Discrete capacitance is not required for proper operation.

6.5 Thermal Information

THERMAL METRIC ⁽¹⁾		TPS6602x	UNIT
		YBG (WCSP)	
		28 PINS	
R _{θJA, EFF}	Effective Junction-to-ambient thermal resistance ⁽²⁾	44.3	°C/W
R _{θJA}	Junction-to-ambient thermal resistance	62.7	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	0.4	°C/W
R _{θJB}	Junction-to-board thermal resistance	13.8	°C/W
ψ _{JT}	Junction-to-top characterization parameter	0.2	°C/W
ψ _{JB}	Junction-to-board characterization parameter	13.7	°C/W
ψ _{JB, EFF}	Effective Junction-to-board characterization parameter ⁽²⁾	14.5	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

(2) Models based on typical application layout.

6.6 PP5V Power Switch Characteristics

Operating under these conditions unless otherwise noted: $-10\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$, $2.85\text{V} \leq V_{\text{VIN}} \leq 5.5\text{V}$, $R_{\text{IREF}} = 75\text{ k}\Omega \pm 1\%$ overall tolerance, $4.9\text{V} \leq V_{\text{PP5V}} \leq 5.5\text{V}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
R _{PP5V}	Resistance from PP5V to VBUS	I _{LOAD} = 1 A, PP5V = 5.0V, T _J = 25°C, SRC 1P5A or SRC 3P0A state.		30	35	mΩ
		I _{LOAD} = 1 A, PP5V = 5.0V, -10 °C ≤ T _J ≤ 125 °C, SRC 1P5A or SRC 3P0A state.		30	50	mΩ
I _{SC_IREF}	Short circuit current from VBUS with IREF terminal shorted.	V _{IREF} = 0V, SRC 1P5A or SRC 3P0A state.			8	A
V _{IREF}	Output voltage	SRC 1.5A state		0.56		V
		SRC 3.0A state		1.13		V
I _{LIM_PP5V_1P5}	Current limit for 1.5A setting	SRC 1.5A state	1.60	1.74	1.87	A
I _{LIM_PP5V_3P0}	Current limit for 3.0A setting	SRC 3.0A state	3.2	3.45	3.7	A
I _{LIMPP5VF}	Difference between current limit and current limit fault flag assertion, I _{LIM5VF} ≤ I _{LIM5V} .	SRC 1P5A or SRC 3P0A state. PP5V = 5V. Sweep load current and monitor FLT transition from 1 to 0 (50% point). C _{FLT} = 20pF, R _{PU} = 10 kΩ to VLDO.		12		mA
t _{LIMIT_FLT}	Time from PP5V current limit detected until FLT asserted low.	SRC 1P5A or SRC 3P0A state. PP5V = 5V. Sweep load current and monitor FLT transition from 1 to 0 (50% point). C _{FLT} = 20pF, R _{PU} = 10 kΩ to VLDO.	4	10	16	ms
V _{PP5V_RCP}	Maximum voltage due to reverse current. Source path disables due to RCP comparator.	SRC 1P5A or SRC 3P0A state. V _{PP5V} = 5.5V, ramp V _{VBUS} from 5.5V to 21V at 75 V/ms, C _{PP5V} = 47μF, measure V _{PP5V}			5.8	V
V _{PP5V_RCP_OVP}	Maximum voltage due to reverse current. Source path disables due to OVP protection on PP5V.	SRC 1P5A or SRC 3P0A state. V _{PP5V} = 5.5V, ramp V _{VBUS} from 5.5V to 21V at 5 V/ms, C _{PP5V} = 4.7μF, measure V _{PP5V}			6.25	V
V _{RCP_THRES_PP5V}	Reverse current blocking voltage threshold for PP5V switch		25	35	45	mV
t _{OS_PP5V}	Response time to VBUS short circuit	VBUS to GND through 10mΩ		2.0		μs
t _{ON_PP5V}	PP5V enable time.	R _L = 100Ω, V _{PP5V} = 5V, C _L =0, Transition from DISABLED state to SRC 1.5A state, V _{VBUS} reaches 90% of final value.	2.6	4.5	5.3	ms
t _{OFF_PP5V}	PP5V disable time.	R _L = 100Ω, V _{PP5V} = 5V, C _L =0, Transition from SRC 1.5A or SRC 3.0A state to DISABLED state, V _{VBUS} at 10% of final value.	0.5	0.7	1.2	ms
t _{RISE_PP5V}	VBUS from 10% to 90% of final value	R _L = 100Ω, V _{PP5V} = 5V, C _L =0, Transition from DISABLED state to SRC 1.5A state	0.5	0.9	1.5	ms
t _{FALL_PP5V}	VBUS from 90% to 10% of initial value	R _L = 100Ω, V _{PP5V} = 5V, C _L =0, Transition from SRC 1.5A or SRC 3.0A state to DISABLED state	0.1	0.16	0.25	ms

6.7 PPHV Power Switch Characteristics

Operating under these conditions unless otherwise noted: $-10\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$, $2.85\text{V} \leq V_{\text{VIN}} \leq 5.5\text{V}$, $R_{\text{IREF}} = 75\text{ k}\Omega \pm 1\%$ overall tolerance

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
R _{PPHV}	Resistance from PPHV to VBUS	I _{LOAD} = 1 A, T _J = 25 °C, SNK state.		22	26	mΩ
		I _{LOAD} = 1 A, -10 °C ≤ T _J ≤ 125 °C, SNK state.		22	45	mΩ
V _{PPHV_RCP}	Maximum voltage due to reverse current during RCP response.	SNK state, V _{VBUS} = 5.5V, ramp V _{PPHV} from 5.5V to 21V at 100 V/ms, C _{VBUS} = 10μF, measure V _{VBUS}			5.8	V
V _{PPHV_OVP}	Maximum voltage rise due to reverse current during VBUS OVP response.	SNK state, V _{VBUS} = 5.5V, set V _{OVP} = 6V, ramp V _{VBUS} from 5.5V to 21V at 100 V/ms, C _{PPHV} = 4.7μF, measure V _{PPHV}			6.2	V
V _{RCP_THRES_PPHV}	Reverse current blocking voltage threshold for PPHV switch		2	6	10	mV
SS	Soft-start slew rate	Transition from DISABLED state to SNK state, V _{VBUS} = 5V, C _{PPHV} = 100μF. Measure slew rate on PPHV.	0.2		0.6	V/ms
t _{ON_PPHV}	PPHV enable time including Soft-start.	R _{PPHV} = 100Ω, V _{VBUS} = 5V, C _{PPHV} = 100 μF. Transition from DISABLED state to SNK state, V _{PPHV} at 90% of final value.	9	15	29	ms
t _{OFF_PPHV}	PPHV disable time.	R _{PPHV} = 100Ω, V _{VBUS} = 5V, C _{PPHV} = 4.7 μF. Transition from SNK state to DISABLED state, V _{PPHV} falls to 4.5V.	0.9	2.2	4.3	ms

6.8 Power Path Supervisory

Operating under these conditions unless otherwise noted: $-10\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$, $2.85\text{V} \leq V_{\text{VIN}} \leq 5.5\text{V}$, $R_{\text{IREF}} = 75\text{ k}\Omega \pm 1\%$ overall tolerance

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
UV_VIN_R	Undervoltage threshold for VIN. VBUS LDO disables when threshold reached.	VIN rising, TPS66020 only.	2.45		2.75	V
		VIN rising, TPS66021 only.	3.89		4.40	V
UV_VIN_F	Undervoltage threshold for VIN. Device resets.	VIN falling, TPS66020 only.	2.35		2.65	V
		VIN falling, TPS66021 only.	3.79		4.30	V
UVH_VIN	Undervoltage hysteresis for VIN.			100		mV
UV_VBUS_R	Undervoltage threshold for VBUS. PPHV switch disabled until threshold reached.	VBUS rising	3.35		3.75	V
UV_VBUS_F	Undervoltage threshold for VBUS. PPHV switch disables when threshold reached.	VBUS falling	3.15		3.55	V
UVH_VBUS	Undervoltage hysteresis for VBUS			200		mV
OVP_REF	OVP reference voltage.		0.93	1	1.07	V
UV_PP5V_R	Undervoltage threshold for PP5V. PP5V switch disabled until threshold reached.	PP5V rising	3.9		4.5	V
UVH_PP5V	Undervoltage hysteresis for PP5V			100		mV
UV_PP5V_F	Undervoltage threshold for PP5V. PP5V switch disables when threshold reached.	PP5V falling	3.8		4.4	V
OV_PP5V_R	Overvoltage threshold for PP5V. PP5V switch disabled if threshold reached.	PP5V rising	5.60	5.9	6.2	V
OV_PP5V_F	Overvoltage threshold for PP5V. PP5V switch enabled if threshold reached.	PP5V falling	5.50	5.8	6.1	V
OVH_PP5V	Overvoltage hysteresis for PP5V			100		mV
VFWD_DROP_VIN	Forward voltage drop across VIN to VLDO switch	I _{VLDO} = 35 mA			90	mV

Power Path Supervisory (continued)

Operating under these conditions unless otherwise noted: $-10\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$, $2.85\text{V} \leq V_{\text{VIN}} \leq 5.5\text{V}$, $R_{\text{IREF}} = 75\text{ k}\Omega \pm 1\%$ overall tolerance

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{\text{VIN_STABLE}}$	When VIN is above UV_VIN_R for this duration, VIN is considered valid. If device is being powered by VBUS LDO, it will then switch to VIN supply and VBUS LDO will be disabled.		5		15	ms

6.9 VBUS LDO Characteristics

Operating under these conditions unless otherwise noted: $-10\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$, $2.85\text{V} \leq V_{\text{VIN}} \leq 5.5\text{V}$, $R_{\text{IREF}} = 75\text{ k}\Omega \pm 1\%$ overall tolerance

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_VBUS_LDO_3V	Output voltage of VBUS LDO	For TPS66020: VIN = 0V, VBUS $\geq 3.8\text{V}$, $0 \leq I_{\text{VBUS_LDO}} \leq 30\text{mA}$	3.07	3.3	3.53	V
V_VBUS_LDO_5V	Output voltage of VBUS LDO	For TPS66021: VIN = 0V, VBUS $\geq 5.5\text{V}$, $0 \leq I_{\text{VBUS_LDO}} \leq 30\text{mA}$	4.65	5.0	5.35	V
VDO_VBUS_LDO_3V	Drop out voltage of VDD LDO	For TPS66020: VIN = 0V, VBUS = 3.135 V, $I_{\text{VBUS_LDO}} = 30\text{ mA}$			0.5	V
VDO_VBUS_LDO_5V	Drop out voltage of VDD LDO	For TPS66021: VIN = 0V, VBUS = 4.75V, $I_{\text{VBUS_LDO}} = 30\text{ mA}$			0.5	V
ILIMIT_VBUS_LDO	Current limit VBUS LDO.	VBUS = 5.5V, VIN = 0V, VLDO = 0V	50		100	mA
$t_{\text{EN_VBUS_LDO}}$	Turn-on time of VBUS LDO.	For TPS66020: $I_{\text{VBUS_LDO}} = 30\text{mA}$, $\text{CVLDO} = 4.7\text{ }\mu\text{F}$, VIN = 0V. Ramp V_{VBUS} from 0 to 5V at $\geq 50\text{V/ms}$. Measure from VBUS = 4.5V to VLDO = 3V.			1.2	ms
		For TPS66021: $I_{\text{VBUS_LDO}} = 30\text{mA}$, $\text{CVLDO} = 4.7\text{ }\mu\text{F}$, VIN = 0V. Ramp V_{VBUS} from 0 to 7.5V at $\geq 50\text{V/ms}$. Measure from VBUS = 7V to VLDO = 4.5V.			1.2	ms

6.10 Thermal Shutdown Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
TSD_PP5V_R	Thermal Shutdown Temperature of the PP5V power path.	Temperature rising	128	150	172	$^{\circ}\text{C}$
TSD_PP5V_F	Thermal Shutdown Temperature of the PP5V power path.	Temperature falling	115	140	165	$^{\circ}\text{C}$
TSDH_PP5V	Thermal Shutdown hysteresis of the PP5V power path.			10		$^{\circ}\text{C}$
TSD_PPHV_R	Thermal Shutdown Temperature of the PPHV power path.	Temperature rising	128	150	172	$^{\circ}\text{C}$
TSD_PPHV_F	Thermal Shutdown Temperature of the PPHV power path.	Temperature falling	115	140	165	$^{\circ}\text{C}$
TSDH_PPHV	Thermal Shutdown hysteresis of the PPHV power path.			10		$^{\circ}\text{C}$
TSD_MAIN_R	Thermal Shutdown Temperature of the entire device.	Temperature rising	140	160	178	$^{\circ}\text{C}$
TSD_MAIN_F	Thermal Shutdown Temperature of the entire device.	Temperature falling	120	140	160	$^{\circ}\text{C}$
TSDH_MAIN	Thermal Shutdown hysteresis of the entire device.			20		$^{\circ}\text{C}$

6.11 Input-output (I/O) Characteristics

Operating under these conditions unless otherwise noted: $-10\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$, $2.85\text{ V} \leq V_{\text{VIN}} \leq 5.5\text{ V}$, $R_{\text{IREF}} = 75\text{ k}\Omega \pm 1\%$ overall tolerance

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
EN_Vt+	Positive going input-threshold voltage, % of VLDO	VLDO = 2.85 - 5.5V	40		70	%
EN_Vt-	Negative going input-threshold voltage, % of VLDO	VLDO = 2.85 - 5.5V	30		60	%
EN_HYS	Input hysteresis voltage, % of VLDO	VLDO = 2.85 - 5.5V		10		%
EN_RPD	Pull-down resistance EN pin.	Measured with pin voltage $V_{\text{EN}} = 3.3\text{ V}$	500	650	800	k Ω
EN_CLAMP	Voltage clamp on EN pin.	$I_{\text{EN}} = 100\text{ }\mu\text{A}$		6	7.1	V
FLT_VOL	Output Low Voltage, $\overline{\text{FLT}}$ pin	$I_{\text{OL}} = 2\text{ mA}$, $\overline{\text{FLT}}$ driven low.			0.4	V
FLT_ILKG	Leakage Current, $\overline{\text{FLT}}$ pin	$\overline{\text{FLT}}$ not driven low.	-1		1	μA
$t_{\text{H_FLT}}$	Time $\overline{\text{FLT}}$ pin remains asserted low.		4	10	16	ms
$t_{\text{DG_EN}}$	Enable deglitch filter. Pulses on EN0 or EN1 $< t_{\text{DG_EN(MIN)}}$ are not propagated to the control logic. Pulses on EN0 or EN1 $> t_{\text{DG_EN(MAX)}}$ are propagated to the control logic. Pulses on EN0 or EN1 $\geq t_{\text{DG_EN(MIN)}}$ and $\leq t_{\text{DG_EN(MAX)}}$ may or may not propagate to the control logic. The filter is not applied to EN1 transition to the FRS state.		78		242	μs

6.12 Power Consumption Characteristics

Operating under these conditions unless otherwise noted: $-10\text{ }^{\circ}\text{C} \leq T_J \leq 85\text{ }^{\circ}\text{C}$, $2.85\text{ V} \leq V_{\text{VIN}} \leq 5.5\text{ V}$, $R_{\text{IREF}} = 75\text{ k}\Omega \pm 1\%$ overall tolerance

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{\text{VIN_DISABLE}}$	Current consumed by $\text{VIN}^{(1)}$	$\text{VIN} = 3.3\text{ V}$, $\text{VBUS} = 0\text{ V}$, $\text{PP5V} = 0\text{ V}$, $\text{PPHV} = 0\text{ V}$, DISABLED state. Measure I_{VIN} . TPS66020 only.		19	27	μA
		$\text{VIN} = 5\text{ V}$, $\text{VBUS} = 0\text{ V}$, $\text{PP5V} = 0\text{ V}$, $\text{PPHV} = 0\text{ V}$, DISABLED state. Measure I_{VIN} . TPS66021 only.		25	36	μA
$I_{\text{VIN_SRC}}$	Current consumed by $\text{VIN}^{(1)}$	$\text{VIN} = 3.3\text{ V}$, $\text{PP5V} = 5.5\text{ V}$, $\text{PPHV} = 0\text{ V}$, SRC 1.5A or SRC 3.0A state. Measure I_{VIN} . TPS66020 only.		136		μA
		$\text{VIN} = 5\text{ V}$, $\text{PP5V} = 5.5\text{ V}$, $\text{PPHV} = 0\text{ V}$, SRC 1.5A or SRC 3.0A state. Measure I_{VIN} . TPS66021 only.		214		μA
$I_{\text{VIN_SNK}}$	Current consumed by $\text{VIN}^{(1)}$	$\text{VIN} = 3.3\text{ V}$, $\text{PP5V} = 0\text{ V}$, SNK state. Measure I_{VIN} . TPS66020 only.		130		μA
		$\text{VIN} = 5\text{ V}$, $\text{PP5V} = 0\text{ V}$, SNK state. Measure I_{VIN} . TPS66021 only.		215		μA

(1) Measured with EN0 and/or EN1 set to GND or VLDO levels as required for the respective state.

Power Consumption Characteristics (continued)

Operating under these conditions unless otherwise noted: $-10\text{ }^{\circ}\text{C} \leq T_j \leq 85\text{ }^{\circ}\text{C}$, $2.85\text{V} \leq V_{\text{VIN}} \leq 5.5\text{V}$, $R_{\text{IREF}} = 75\text{ k}\Omega \pm 1\%$ overall tolerance

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$I_{\text{SD_PP5V}}$	Current consumed by PP5V ⁽¹⁾	VIN = 3.3V, PP5V = 5.5V, PPHV = 0V, VBUS = 0V, DISABLED state. Measure I_{PP5V} . TPS66020 only.			2		μA
		VIN = 5V, PP5V = 5.5V, PPHV = 0V, VBUS = 0V, DISABLED state. Measure I_{PP5V} . TPS66021 only.			2		μA
$I_{\text{ACT_PP5V}}$	Current consumed by PP5V ⁽¹⁾	VIN = 3.3V, PP5V = 5.5V, PPHV = 0V, SRC 1.5A or SRC 3.0A state. Measure I_{PP5V} . TPS66020 only.			109		μA
		VIN = 5V, PP5V = 5.5V, PPHV = 0V, SRC 1.5A or SRC 3.0A state. Measure I_{PP5V} . TPS66021 only.			109		μA
$I_{\text{SD_VBUS}}$	Current consumed by VBUS ⁽¹⁾	VIN = 3.3V, PP5V = 0V, PPHV = 0V, DISABLED state. Measure I_{VBUS} . TPS66020 only.	VBUS = 5.5V		12	26	μA
			VBUS = 22V		34		μA
		VIN = 5V, PP5V = 0V, PPHV = 0V, DISABLED state. Measure I_{VBUS} . TPS66021 only.	VBUS = 5.5V		8		μA
			VBUS = 22V		30		μA
$I_{\text{SD_VBUS_LDO}}$	Current consumed by VBUS ⁽¹⁾	VIN = 0V, PP5V = 0V, PPHV = 0V, DISABLED state. Measure I_{VBUS} .	VBUS = 5.5V		45		μA
			VBUS = 22V		69		μA
$I_{\text{ACT_VBUS}}$	Current consumed by VBUS ⁽¹⁾	VIN = 3.3V, PP5V = 0V, SNK state. Measure I_{VBUS} . TPS66020 only.	VBUS = 5.5V		325		μA
			VBUS = 22V		360		μA
		VIN = 5V, PP5V = 0V, SNK state. Measure I_{VBUS} . TPS66021 only.	VBUS = 5.5V		342		μA
			VBUS = 22V		377		μA
$V_{\text{OC_VBUS}}$	Open circuit voltage, VBUS	PP5V = 5.5V, PPHV = 22V, DISABLED state, no DC loading on VBUS. Measure V_{VBUS} under steady state conditions.				0.8	V
$V_{\text{OC_PP5V}}$	Open circuit voltage, PP5V	VBUS = 22V, PPHV = 0V, DISABLED state, no DC loading on PP5V. Measure V_{PP5V} under steady state conditions.				0.8	V
$V_{\text{OC_PPHV}}$	Open circuit voltage, PPHV	VBUS = 22V, PP5V = 0V, DISABLED state, no DC loading on PPHV. Measure V_{PPHV} under steady state conditions.				0.8	V

6.13 Typical Characteristics

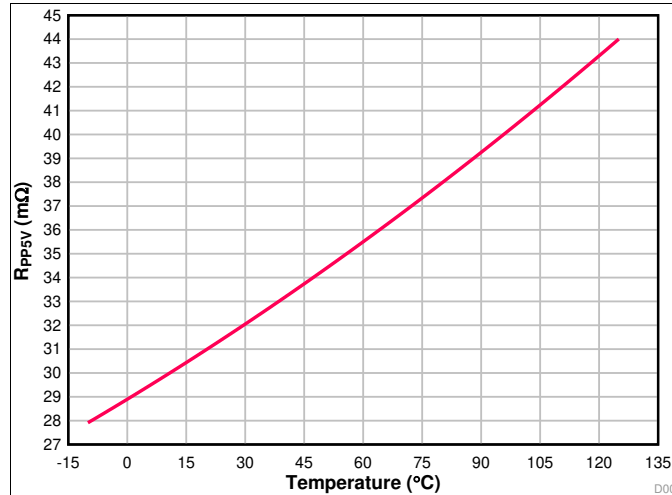


Figure 1. R_{PP5V} versus Temperature

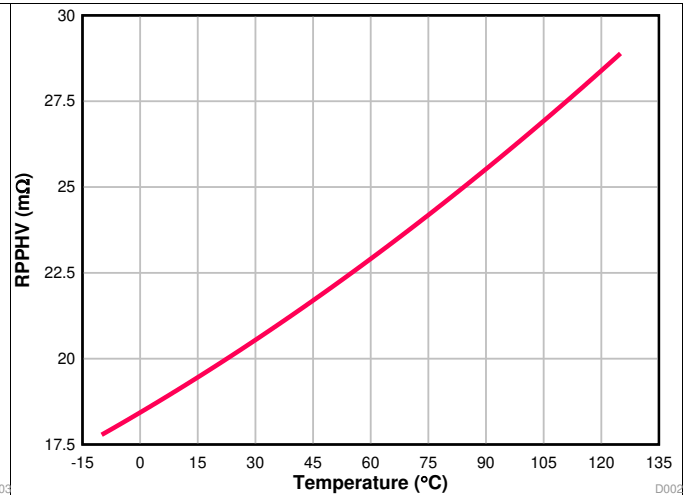


Figure 2. R_{PPHV} versus Temperature

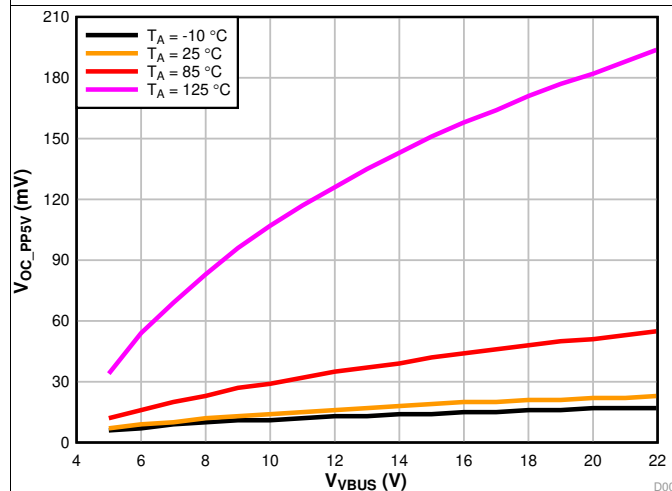


Figure 3. V_{OC_PP5V} , PP5V Open Circuit Voltage versus VBUS

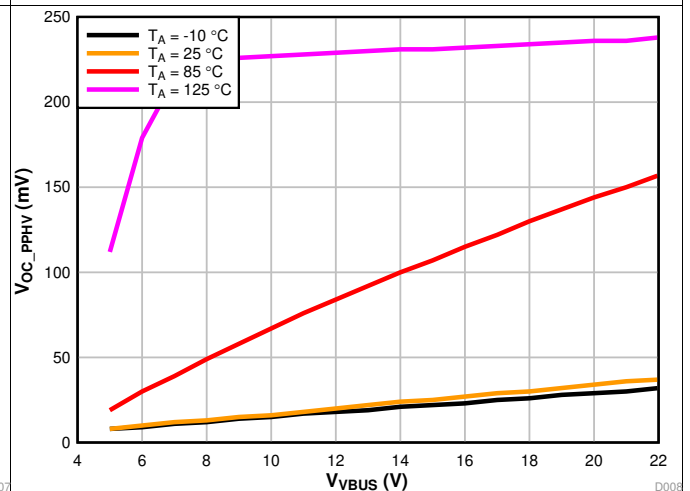


Figure 4. V_{OC_PPHV} , PPHV Open Circuit Voltage versus VBUS

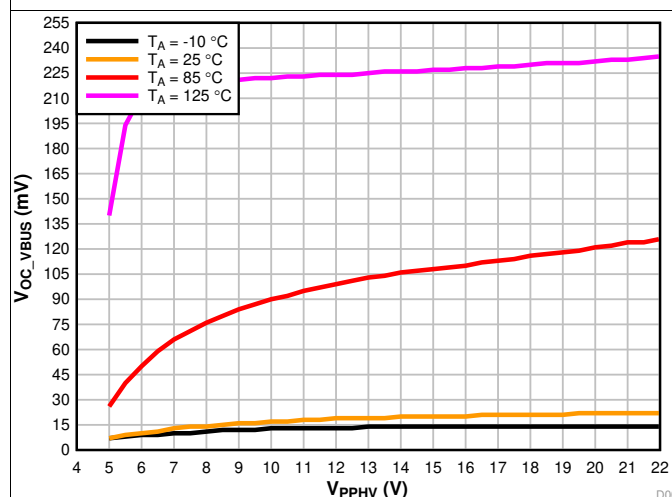


Figure 5. V_{OC_VBUS} , VBUS Open Circuit Voltage versus PPHV

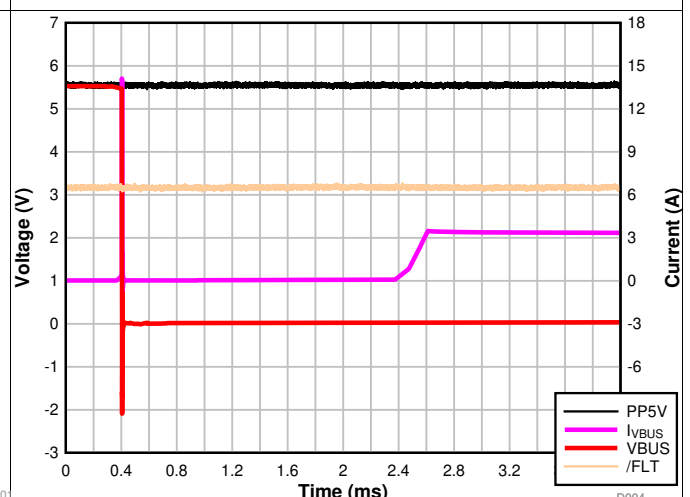


Figure 6. PP5V Current Limit (3 A) Response with Short (Zoomed Out)

Typical Characteristics (continued)

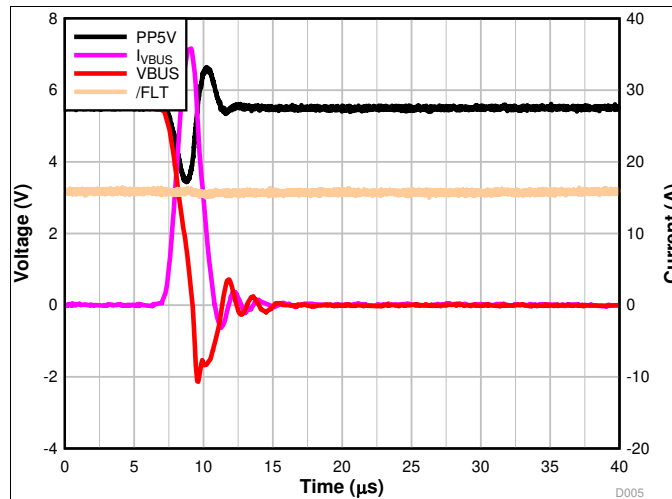


Figure 7. PP5V Current Limit (3 A) Response with Short (Zoomed In At Time of Short)

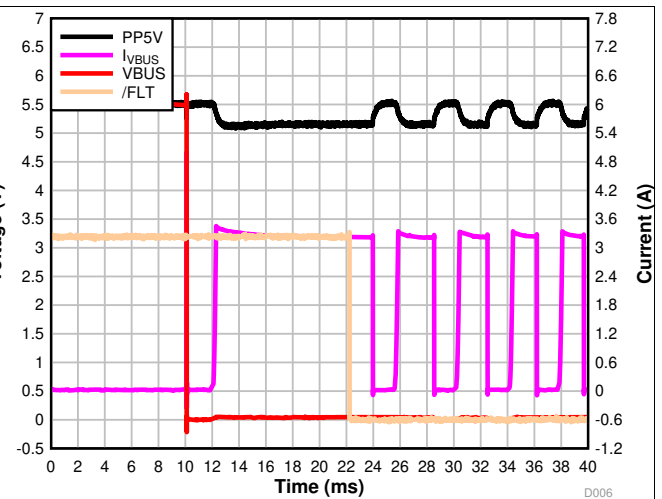


Figure 8. PP5V Current Limit (3 A) Response with Persistent Short Showing TSD Protection and Recovery

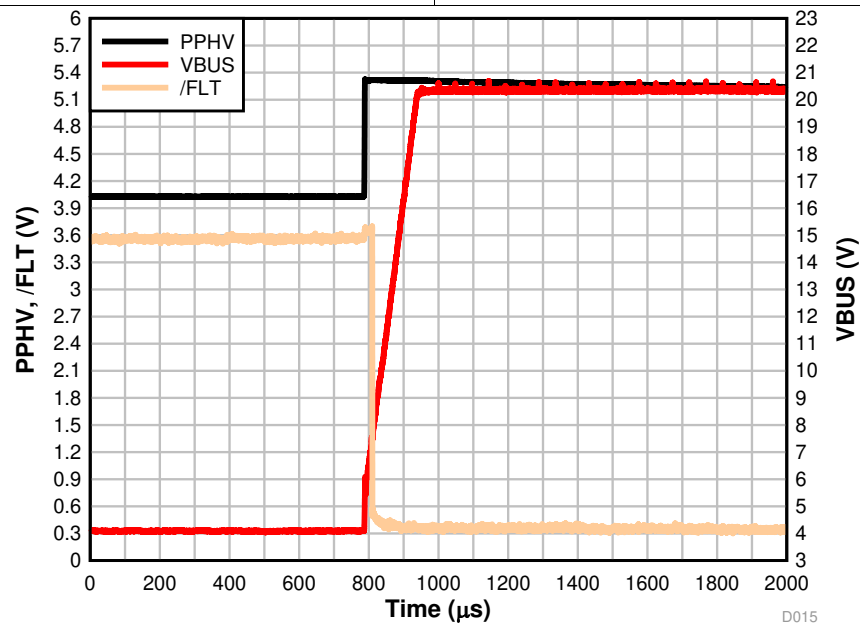


Figure 9. VBUS OVP Response with 6-V Threshold

7 Parameter Measurement Information

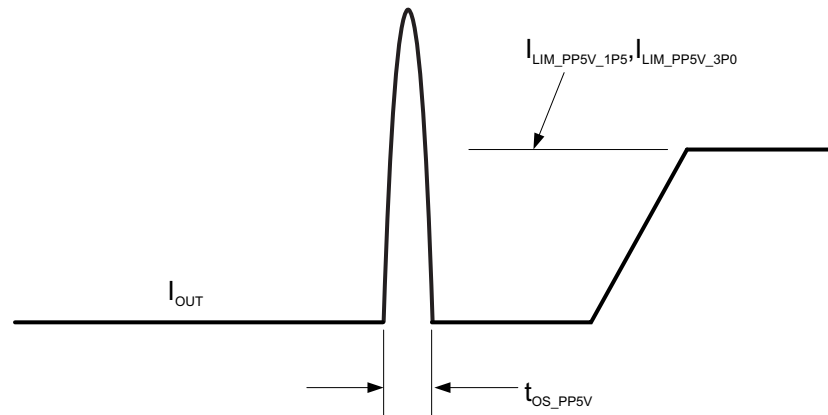


Figure 10. PP5V to VBUS Short Circuit Parameter Diagram

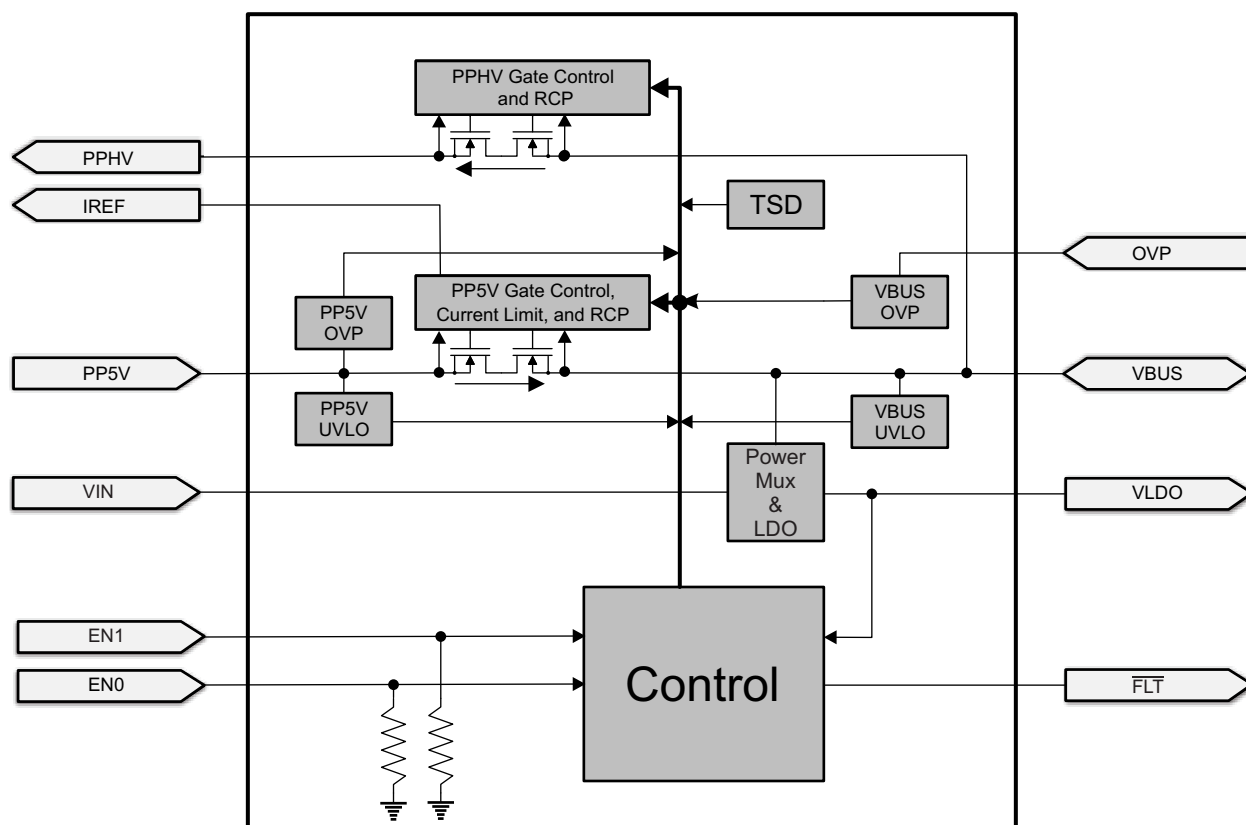
8 Detailed Description

8.1 Overview

The TPS6602x is a fully featured power multiplexer with an integrated Source power path, a Sink power path, and a high voltage VBUS LDO voltage regulator. The Source power path can supply 5-V nominal power and supports two current limit settings (1.5 A or 3 A) controlled by general-purpose I/O. The Source power path includes current limit protection, overtemperature protection, reverse-current protection, undervoltage protection, and overvoltage protection. See the [5-V Source \(PP5V Power Path\)](#) section. The Sink power path can support up to 5 A at 20 V controlled by general-purpose I/O. The Sink power path includes soft-start to minimize in-rush currents, overtemperature protection, reverse-current protection, undervoltage protection, and an optional overvoltage protection configured in the application. See the [20-V Sink \(PPHV Power Path\)](#) section. The TPS6602x fully supports Fast Role Swap operation as specified in the Power Delivery specification. See the [Fast Role Swap \(FRS\)](#) section.

The VBUS low dropout voltage regulator may be used in systems that require power during dead battery conditions and can provide up to 30 mA to the system via the VLDO pin. Once VIN power is available, VLDO pin power is switched from the VBUS LDO regulator to the VIN pin. The TPS66020 device VBUS LDO regulator nominally supplies 3.3 V where the TPS66021 device VBUS LDO nominally supplies 5 V. See the [Power Management and Supervisory](#) section.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 5-V Source (PP5V Power Path)

The PP5V power path uses two back-to-back N-channel MOSFETs, and blocks current in both directions when the power path is disabled. The PP5V power path is a Source only path and when enabled provides power from the PP5V terminal to the VBUS terminal. The PP5V path provides up to 3-A current delivery to VBUS.

Feature Description (continued)

8.3.1.1 PP5V Current Limit

The current through PP5V to VBUS current limit may be dynamically selected to support 1.5-A or 3-A operation via EN0 and EN1. An external resistance to GND on IREF terminal is required to set the bias current for accurate current limit operation.

Under overload conditions, the internal current-limit regulator limits the output current to the selected current limit setting, I_{LIM_PP5V} , where I_{LIM_PP5V} is $I_{LIM_PP5V_1P5}$ or $I_{LIM_PP5V_3P0}$, as shown in the [PP5V Power Switch Characteristics](#) table. When an overload condition is present, the device maintains a constant output current, with the output voltage determined by $(I_{LIM_PP5V} \times R_{LOAD})$. Two possible overload conditions can occur. The first overload condition occurs when either: 1) PP5V input voltage is first applied, PP5V source path is enabled ($EN1_EN0 = 10b$ or $EN1_EN0 = 11b$), and a short circuit is presented (load which draws $I_{OUT} > I_{LIM_PP5V}$), or 2) PP5V input voltage is present and the PP5V source path is enabled into a short circuit. The output voltage is held near zero potential with respect to ground and the TPS6602x ramps the output current to I_{LIM_PP5V} . The TPS6602x limits the current to I_{LIM_PP5V} until the overload condition is removed or the device begins to thermal cycle. This is demonstrated in [Figure 31](#) where the device was enabled into a short, and subsequently cycles current off and on as the thermal protection engages.

The second condition is when an overload occurs while the PP5V source path is enabled and fully turned on. The device responds to the overload condition within time t_{OS_PP5V} (see [Figure 10](#)) when the specified overload (per Electrical Characteristics) is applied. The response speed and shape vary with the overload level, input circuit and rate of application. The current-limit response varies between simply settling to I_{LIM_PP5V} or turning off and a controlled return to I_{LIM_PP5V} . Similar to the previous case, the TPS6602x limits the current to I_{LIM_PP5V} until the overload condition is removed or the device begins to thermal cycle. The TPS6602x thermal cycles if an overload condition is present long enough to activate thermal limiting in any of the above cases. This is due to the relatively large power dissipation $[(V_{PP5V} - V_{VBUS}) \times I_{LIM_PP5V}]$ elevating the junction temperature. The PP5V source path turns off when its temperature reaches its thermal shutdown temperature of TSD_PP5V_R while in current limit. The PP5V source path remains off until its temperature cools to TSD_PP5V_F and then re-enables automatically.

8.3.1.2 PP5V Reverse Current Protection (RCP)

When the PP5V power path is enabled, the RCP circuitry monitors the voltage across the path. If the RCP monitor detects $V_{VBUS} - V_{PP5V} \geq V_{RCP_THRES_PP5V}$, the PP5V path will be disabled preventing additional current flow from VBUS to PP5V. The power path will be completely disabled and remain disabled as long as the RCP condition persists. After the RCP event, the PP5V path will automatically re-enable. $\overline{FLT}$ is asserted when a reverse current protection event occurs on the PP5V path.

8.3.2 20-V Sink (PPHV Power Path)

The PPHV path is a Sink only path, providing power from the VBUS terminal to the PPHV terminal when enabled. The PPHV power path uses two back-to-back N-channel MOSFETs, and blocks current in both directions when the power path is disabled.

8.3.2.1 PPHV Soft Start

The TPS6602x PPHV power path has soft start circuitry to control in-rush current when the PPHV power path is enabled. DC loading should be minimized during soft start since the PPHV path may experience high power dissipation especially at higher VBUS voltages. This may lead to a PPHV overtemperature protection event.

8.3.2.2 PPHV Reverse Current Protection (RCP)

When the PPHV power path is enabled, the RCP circuitry monitors the voltage across the path. If the RCP monitor detects $V_{PPHV} - V_{VBUS} \geq V_{RCP_THRES_PPHV}$, the PPHV path will be disabled preventing additional current flow from PPHV to VBUS. The power path will be completely disabled and remain disabled as long as the RCP condition persists. After the RCP event, the PPHV path will automatically re-enable. $\overline{FLT}$ is not asserted when a reverse current protection event occurs on the PPHV path.

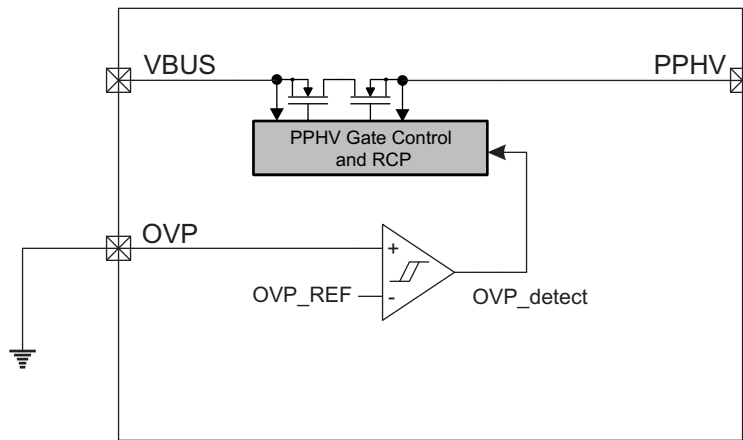


Figure 12. VBUS OVP Disabled

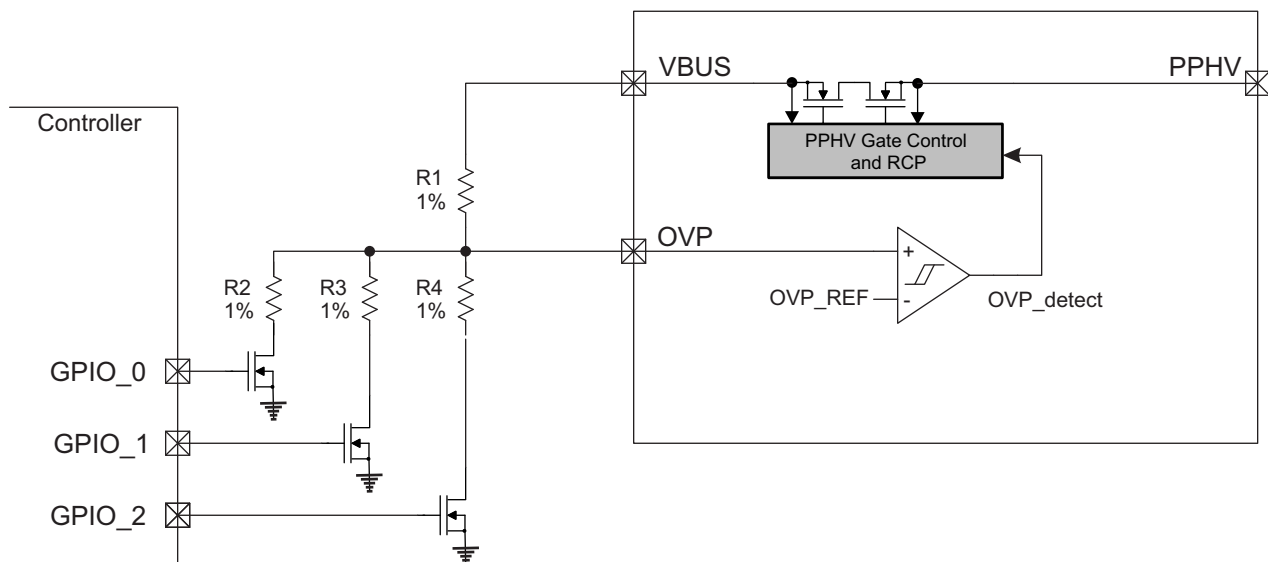


Figure 13. Selectable VBUS OVP Thresholds

8.3.5 Power Management and Supervisory

The TPS6602x Power Management block receives power from VIN or VBUS and generates voltages to provide power to the TPS6602x internal circuitry, as well as, provides power to VLDO. The power supply management and supervisory block is shown in [Figure 14](#).

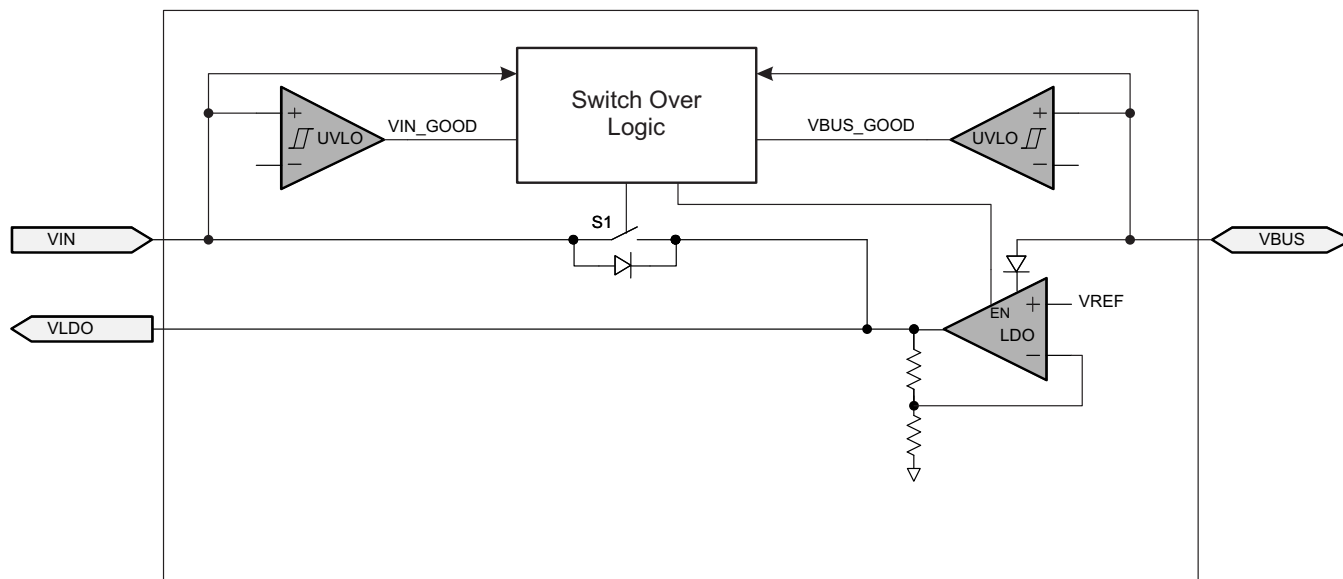


Figure 14. Power Management and Supervisory

The VLDO terminal may be powered from either VIN or VBUS. The normal power supply input is VIN. When VIN is present, S1 is closed and current flows from VIN to VLDO and the VBUS LDO is disabled. When VIN power is unavailable, as in a dead battery condition, the VBUS LDO will be automatically enabled when VBUS is present, and the VLDO terminal is powered by the VBUS LDO. The Switch Over Logic provides the decision making capability to choose VIN or VBUS power, depending on the state of these voltages (based on their respective UVLO comparators) and their relative levels to each other.

8.3.5.1 Supply Connections

Figure 15 shows the TPS66020 VIN being supplied from a 3.3-V supply. The VLDO output may or may not be used to supply other circuitry in the application, for example a PD Controller. During a dead battery condition, the internal 3.3-V VBUS LDO provides power to the TPS66020 and the VLDO output. Once VIN input supply becomes available, the VBUS LDO is disabled and VIN provides power to the VLDO output.

The TPS66021 is well suited for 5 V only systems. VIN of the TPS66021 may be powered from an independent supply, but in most applications it will be connected to the PP5V supply. Figure 16 shows where the VIN supply is shared with PP5V. The VLDO output may be used optionally to supply power to external circuitry. During a dead battery condition, the internal 5-V VBUS LDO provides power to the TPS66021 and the VLDO output. Once the VIN input supply, in this case PP5V, becomes available, the VBUS LDO is disabled and PP5V provides power to the VLDO output.

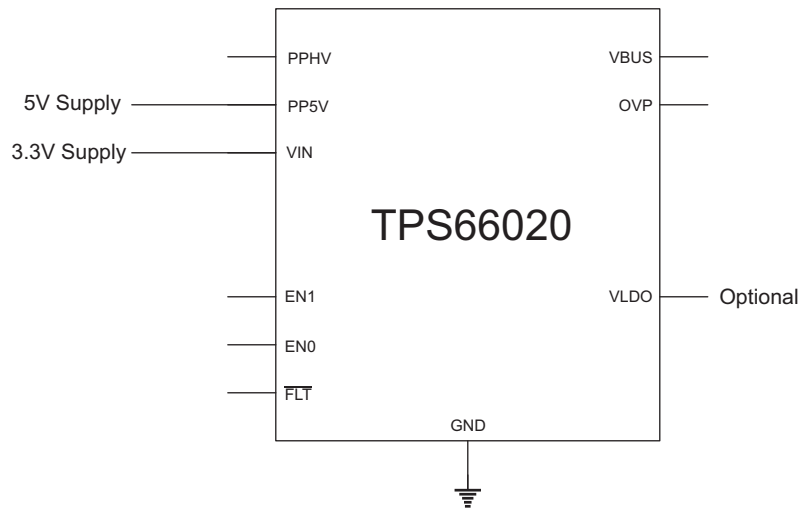


Figure 15. TPS66020 VIN 3.3-V Supply

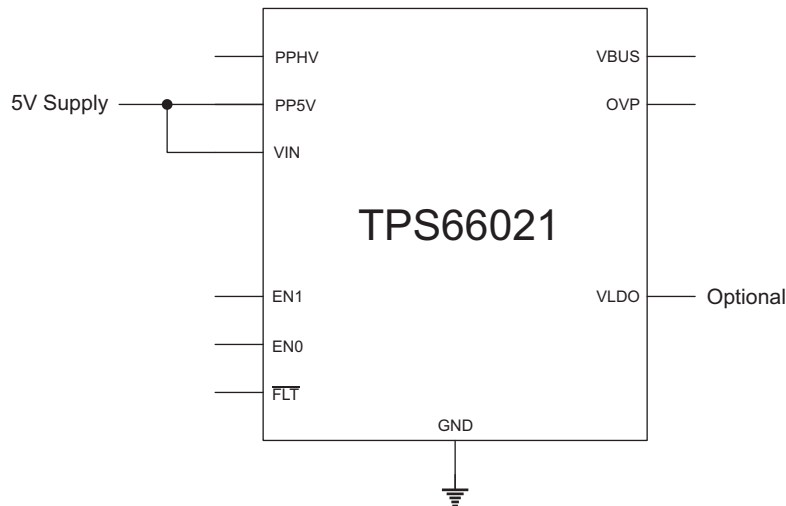
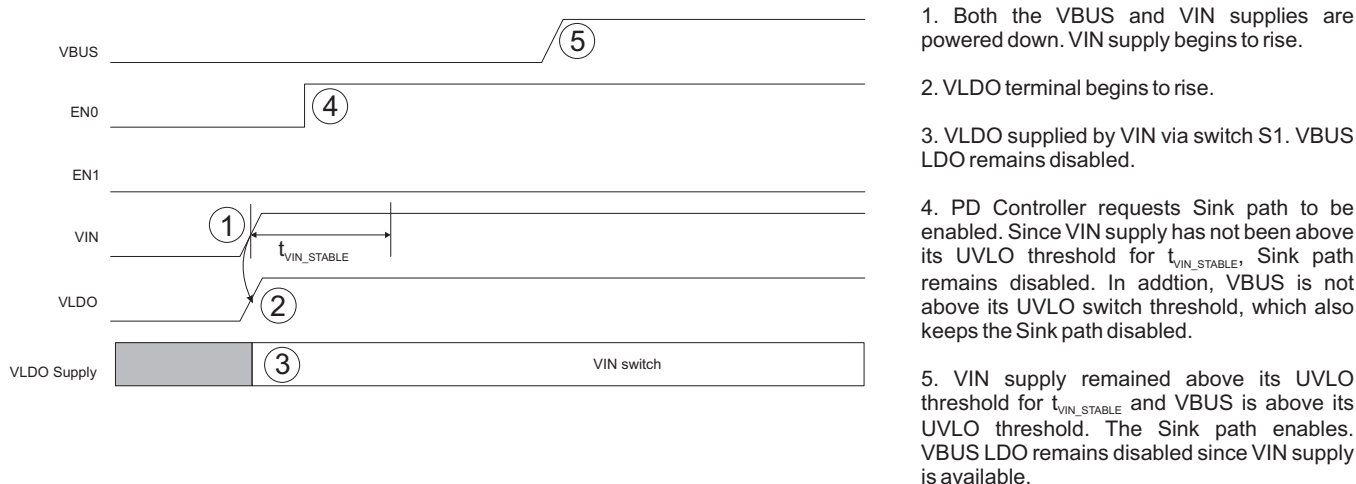


Figure 16. TPS66021 VIN 5-V Shared Supply

8.3.5.2 Power Up Sequences

8.3.5.2.1 Normal Power Up

Figure 17 shows a typical power up sequence. During normal power up, VIN supplies power to the TPS6602x. In this case, VBUS remains powered down. It is assumed a PD Controller is controlling the TPS6602x, and Sink operation is being requested.

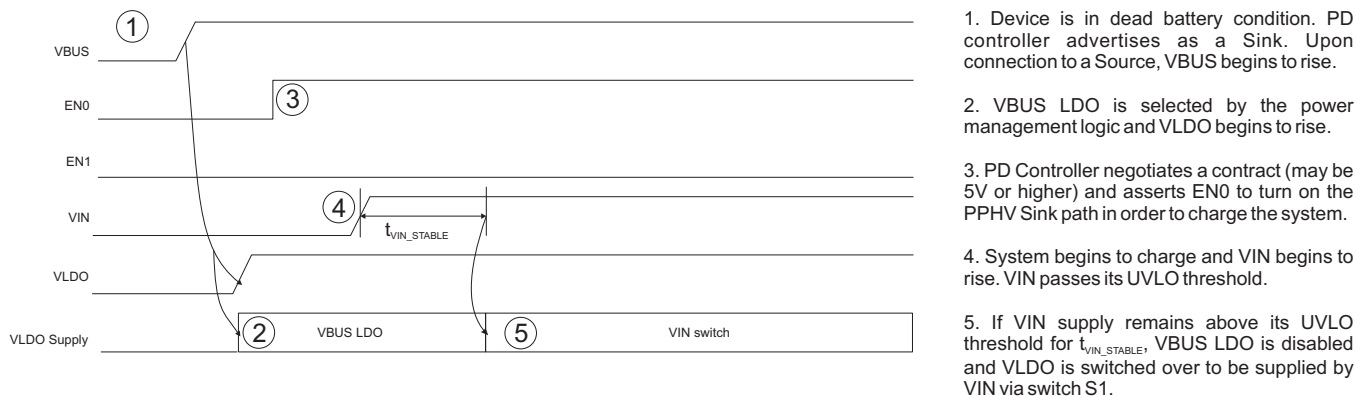

Figure 17. Normal Power Up Sequence

8.3.5.2.2 Dead Battery Operation

Figure 18 shows the typical power up sequence during a dead battery condition. During a dead battery condition, the TPS6602x is internally powered by the VBUS LDO. The VBUS LDO may be used to supply a limited amount of current for use in the system during dead battery, such as supplying power to a PD controller. In this case, it is assumed the VLDO terminal is providing power to a PD controller that is controlling the TPS6602x. Once VIN is stable, the VLDO terminal switches from being supplied by the VBUS LDO to being supplied by the VIN terminal, and the VBUS LDO is automatically disabled. The switch over process is completely seamless.

NOTE

Switching from VBUS LDO operation to VIN operation is seamless and no device reset will occur. When switching from VIN power to VBUS LDO operation, the switch over circuitry will attempt to switch over to the VBUS LDO, however it is not assured that the VLDO level will be maintained above the VLDO UVLO threshold. In this case, a device reset may or may not occur.


Figure 18. Dead Battery Power Up Sequence

8.4 Device Functional Modes

8.4.1 State Transitions

EN0 and EN1 are used by the application to control the state of the device. Figure 19 shows the supported state transitions.

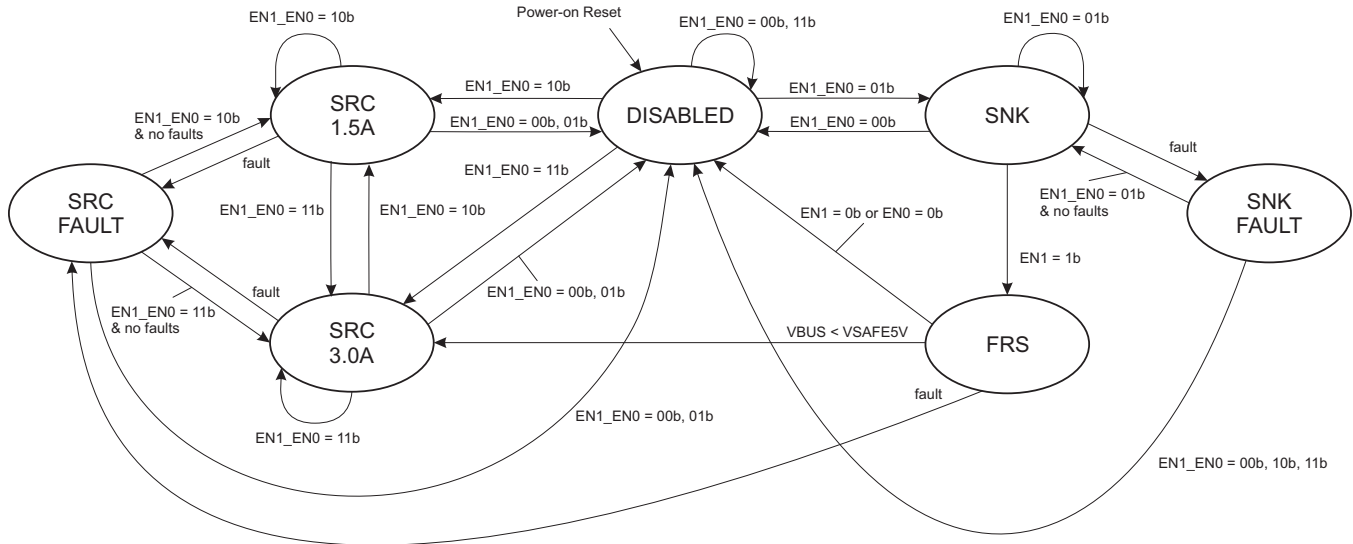


Figure 19. TPS6602x Functional State Diagram

8.4.1.1 DISABLED State

In the DISABLED state, EN1 = 0, EN0 = 0. While in the DISABLED state:

- PP5V power path is disabled
- PP5V current limit, overvoltage, overtemperature, and reverse current protections are disabled
- PPHV power path is disabled
- PPHV overtemperature, reverse-current, and VBUS overvoltage protections are disabled
- VIN and VBUS undervoltage lockout are enabled

The following transitions are possible from the DISABLED state:

- SRC 1.5-A state if (EN1 = 1) and (EN0 = 0) and (PP5V UVLO event not detected) and (PPHV path is completely off)
- SRC 3.0-A state if (EN1 = 1) and (EN0 = 1) and (PP5V UVLO event not detected) and (PPHV path is completely off)
- SNK state if (EN1 = 0) and (EN0 = 1) and (VBUS UVLO event not detected) and (PP5V is completely off)

8.4.1.2 SRC 1.5-A State

In the SRC 1.5-A state, EN1 = 1, EN0 = 0. While in the SRC 1.5-A state:

- PP5V power path is enabled with current limit set to $I_{LIM_PP5V_1P5}$
- PP5V overvoltage, overtemperature and reverse current protections are enabled
- PPHV power path is disabled
- PPHV overtemperature, reverse-current and VBUS overvoltage protections are disabled
- VIN and PP5V undervoltage lockout are enabled

The following transitions are possible from the SRC 1.5-A state:

- SRC 3-A state if (EN1 = 1) and (EN0 = 1)
- DISABLED state if:
 - (EN1 = 0) and (EN0 = 0) -or-
 - (EN1 = 0) and (EN0 = 1)

Device Functional Modes (continued)

- SRC FAULT state if:
 - PP5V UVLO, PP5V OVP, or PP5V RCP event detected -or-
 - PP5V current limit and PP5V TSD events detected

8.4.1.3 SRC 3-A State

In the SRC 3-A state, EN1 = 1, EN0 = 1. While in the SRC 3-A state:

- PP5V power path is enabled with current limit set to $I_{LIM_PP5V_3P0}$
- PP5V overvoltage, overtemperature and reverse current protections are enabled
- PPHV power path is disabled
- PPHV overtemperature, reverse-current, and VBUS overvoltage protections are disabled
- VIN and PP5V undervoltage lockout are enabled

The following transitions are possible from the SRC 3-A state:

- SRC 1.5-A state if (EN1 = 1) and (EN0 = 0)
- DISABLED state if:
 - (EN1 = 0) and (EN0 = 0) -or-
 - (EN1 = 0) and (EN0 = 1)
- SRC FAULT state if:
 - PP5V UVLO, PP5V OVP, or PP5V RCP event detected -or-
 - PP5V current limit and PP5V TSD events detected

8.4.1.4 SNK State

In the SNK state, EN1 = 0, EN0 = 1. While in the SNK state:

- PP5V power path is disabled
- PP5V overvoltage, overtemperature and reverse current protections are disabled
- PPHV power path is enabled
- PPHV overtemperature, VBUS overvoltage (if OVP terminal not grounded) and reverse-current protections are enabled
- VIN and VBUS undervoltage lockout are enabled

The following transitions are possible from the SNK state:

- FRS (Fast Role Swap) state
- DISABLED state if:
 - (EN1 = 0) and (EN0 = 0)
- SNK FAULT state if:
 - VBUS OVP (if OVP terminal not grounded) event detected -or-
 - PPHV TSD event detected

8.4.1.5 FRS (Fast Role Swap) State

In the FRS state, EN1 = 1, EN0 = 1. The FRS state is a transitional state, that transitions automatically from the SNK state to the SRC 3-A state upon successful completion of the fast role swap sequence:

- PPHV power path is automatically disabled
- PPHV overtemperature, VBUS overvoltage (if OVP terminal not grounded) protections are disabled
- VIN and PP5V undervoltage lockout are enabled
- PP5V power path is automatically enabled along with its overvoltage, overtemperature and RCP protection circuits upon successfully completing the fast role swap sequence.

The following transitions are possible from the FRS state:

- SRC 3-A state. This transition is automatic upon successful completion of the fast role swap sequence.
- DISABLED state if:
 - (EN1 = 0) or (EN0 = 0). This may allow for exiting a FRS sequence depending on the current status of the

Device Functional Modes (continued)

FRS sequence.

- SRC FAULT state if:
 - PP5V UVLO, PP5V OVP event detected -or-
 - PP5V current limit and PP5V TSD events detected

8.4.2 SRC FAULT State

The SRC FAULT state is entered when any PP5V fault event is detected. Upon entering the SRC FAULT state, the PP5V power path is disabled. The following transitions are possible from the SRC FAULT state:

- DISABLED state if:
 - (EN1 = 0) and (EN0 = 0) -or-
 - (EN1 = 0) and (EN0 = 1)
- SRC 1.5-A state if:
 - (EN1 = 1) and (EN0 = 0) -and-
 - PP5V TSD, PP5V OVP, PP5V RCP, PP5V UVLO, and PP5V current limit events are not detected.
- SRC 3-A state if:
 - (EN1 = 1) and (EN0 = 1) -and-
 - PP5V TSD, PP5V OVP, PP5V RCP, PP5V UVLO, and PP5V current limit events are not detected.

8.4.3 SNK FAULT State

The SNK FAULT state is entered when any PPHV fault event is detected. Upon entering the SNK FAULT state, the PPHV power path is disabled. The following transitions are possible from the SNK FAULT state:

- DISABLED state if:
 - (EN1 = 1) or (EN0 = 0)
- SNK state if:
 - (EN1 = 0) and (EN0 = 1) -and-
 - PPHV TSD, VBUS OVP (if OVP terminal not grounded) events are not detected

8.4.4 Device Functional Mode Summary

[Table 2](#) summarizes the functional modes for the TPS6602x. As shown, the enabling and disabling of the respective Source or Sink is dependent upon the voltages present on PP5V and VBUS, as well as, the EN0 and EN1 control signals.

Device Functional Modes (continued)
Table 2. TPS6602x Device Functional Modes⁽¹⁾

EN1	EN0	VIN	V _{VBUS}	V _{PP5V}	FLT	Device State	Source Path	Sink Path
0	0	≥ UV_VIN	X	X	Hi-Z	DISABLED	Disabled Safety engaged.	Disabled Safety engaged.
1	0	≥ UV_VIN	X	≥ UV_PP5V	Hi-Z	SRC 1.5 A	Enabled RCP, OVT, ILIM 1.5-A enabled.	Disabled Safety engaged.
					L	SRC FAULT	Disabled OVP, OVT, ILIMIT, or RCP event.	Disabled Safety engaged.
				< UV_PP5V	L	SRC FAULT	Disabled PP5V UVLO event.	Disabled Safety engaged.
1	1	≥ UV_VIN	X	≥ UV_PP5V	Hi-Z	SRC 3 A	Enabled RCP, OVT, ILIM 3-A enabled.	Disabled Safety engaged.
					L	SRC FAULT	Disabled OVP, OVT, ILIMIT, or RCP event.	Disabled Safety engaged.
				< UV_PP5V	L	SRC FAULT	Disabled PP5V UVLO event.	Disabled Safety engaged.
0	1	≥ UV_VIN	≥ UV_VBUS	X	Hi-Z	SNK	Disabled Safety engaged.	Enabled RCP, OVT enabled
				X	Hi-Z	SNK FAULT	Disabled Safety engaged.	Enabled with Blocking RCP event.
				X	L	SNK FAULT	Disabled Safety engaged.	Disabled OVP ⁽²⁾ or OVT event.
			< UV_VBUS	X	Hi-Z	SNK FAULT	Disabled Safety engaged.	Disabled VBUS UVLO event.
1	1	≥ UV_VIN	≥ vSafe5V	≥ UV_PP5V	Hi-Z	FRS	Disabled OVT, ILIM 3-A enabled	Disabled Safety engaged.
			< vSafe5V	≥ UV_PP5V	Hi-Z	SRC 3 A	Enabled RCP, OVT, ILIM 3-A enabled	Disabled Safety engaged.
				≥ UV_PP5V	L	SRC FAULT	Disabled OVP, OVT, ILIMIT, or RCP event.	Disabled Safety engaged.
				< UV_PP5V	L	SRC FAULT	Disabled PP5V UVLO event.	Disabled Safety engaged.
X	X	< UV_VIN	< UV_VBUS	X	Hi-Z	DISABLED	Disabled Safety engaged.	Disabled Safety engaged.
0	0	< UV_VIN	≥ UV_VBUS	X	Hi-Z	DISABLED	Disabled Safety engaged.	Disabled Safety engaged.
1	0	< UV_VIN	≥ UV_VBUS	≥ UV_PP5V	L	SRC FAULT	Disabled RCP, OVT, ILIM 1.5A enabled	Disabled Safety engaged.
1	1	< UV_VIN	≥ UV_VBUS	≥ UV_PP5V	L	SRC FAULT	Disabled RCP, OVT, ILIM 3A enabled	Disabled Safety engaged.

⁽¹⁾ X: do-not-care.

⁽²⁾ When OVP function used and VBUS exceeds OVP threshold, V_{VBUS_OVP_THRESHOLD}.

Device Functional Modes (continued)

Table 2. TPS6602x Device Functional Modes⁰ (continued)

EN1	EN0	VIN	V _{VBUS}	V _{PP5V}	FLT	Device State	Source Path	Sink Path
0	1	< UV_VIN	$\geq$ UV_VBUS ⁽³⁾	X	Hi-Z	SNK	Disabled Safety engaged.	Enabled RCP, OVT enabled
				X	Hi-Z	SNK FAULT	Disabled Safety engaged.	Enabled with Blocking RCP event.
				X	L	SNK FAULT	Disabled Safety engaged.	Disabled OVP ⁽²⁾ or OVT event.
			< UV_VBUS ⁽³⁾	X	Hi-Z	SNK FAULT	Disabled Safety engaged.	Disabled VBUS UVLO event.

(3) In this case VLDO is supplying power to the device.

8.4.5 Enabling the PP5V Source Path

The timing diagram of enabling the PP5V Source path with a current limit set to 1.5 A is shown in [Figure 20](#). As shown, transitions from either the Source path to the Sink path or vice-versa always requires a transition first to the DISABLED state, EN1_EN0 = 00b. [Figure 21](#) shows the timing diagram going from a Sink to a 3-A Source. [Figure 22](#) shows changing the current limit back to 1.5 A from its original 3-A setting.

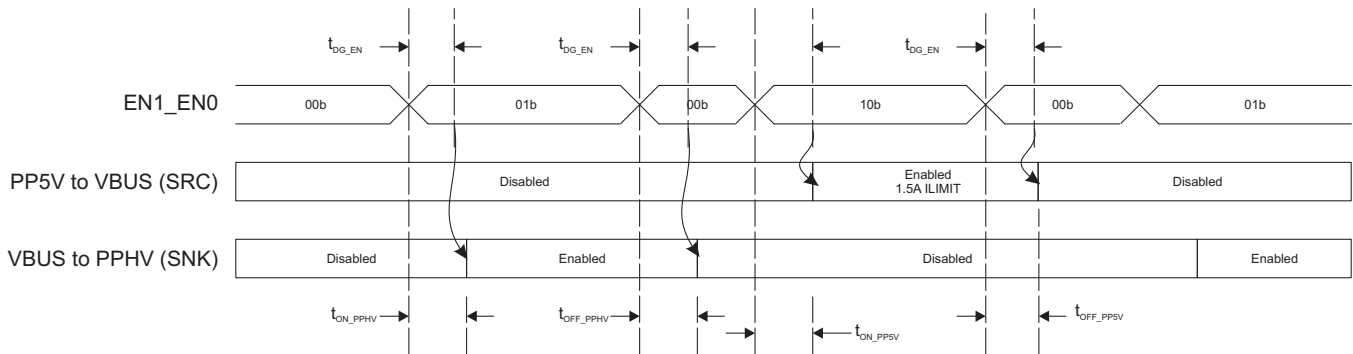


Figure 20. Enabling the PP5V Source Path to 1.5-A Current Limit

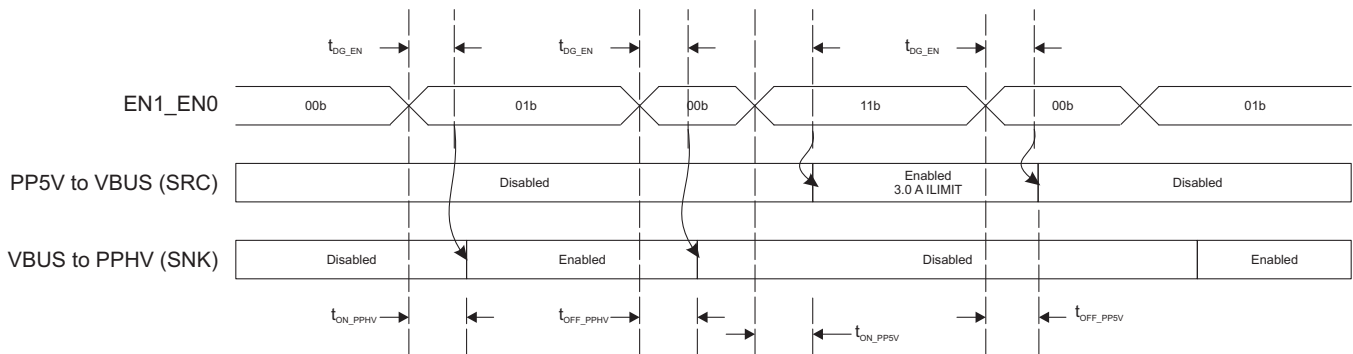


Figure 21. Enabling the PP5V Source Path to 3-A Current Limit

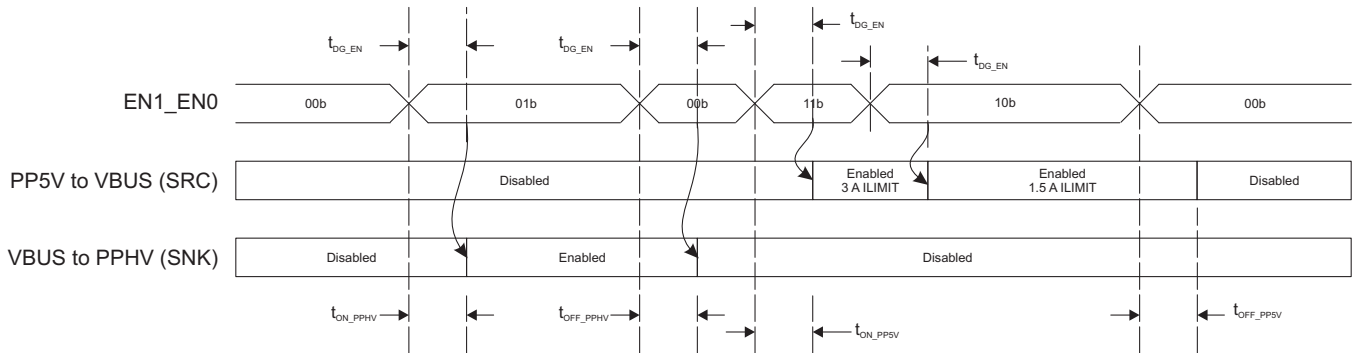


Figure 22. Changing the PP5V Source Path from 3-A to 1.5-A Current Limit

8.4.6 Enabling the PPHV Sink Path

The timing diagram of enabling the PPHV Sink path is shown in Figure 23. As stated earlier, transitions from either the Source path to the Sink path or vice-versa always requires a transition first to the DISABLED state, EN1_EN0 = 00b.

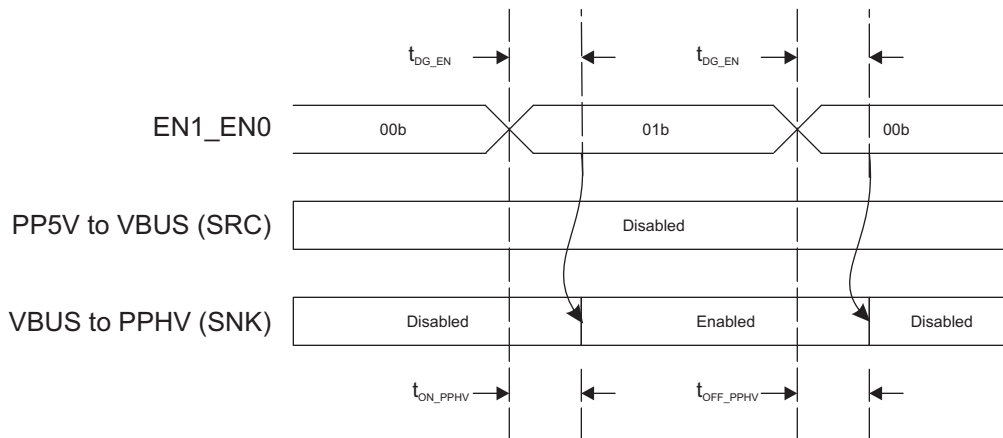


Figure 23. Enabling the PPHV Sink Path

8.4.7 Fast Role Swap (FRS)

8.4.7.1 Overview

For a hub application, the hub may be supplied by an external power source that is supplying power to a Host (via the Source path of the dual-role power (DRP) of the hub), as well as, a downstream Bus Powered Device (BPD) (DFP Source to the BPD). A communication path is formed from Host to the Bus Powered Device. Prior to FRS, power flows from the external power source to the Host and the Bus Powered Device. If the external power is removed, FRS operation will attempt to change the power role of the Host to a Source and the hub DRP port to a Sink allowing power to change direction from the Host to the BPD in an attempt to maintain the connection. It should be noted that after FRS, the contract is 5 V. Refer to the PD3.0 specification for further details on the Fast Role Swap function.

Two PD controllers are used in the FRS process. One PD controller resides on the Host side (USB PD Capable Host); the other resides on the hub side (USB PD Capable Hub). Both PD controllers are DRP since they must support power role swapping. Prior to FRS, the Hub DRP is a Source (known as the old Source) and may be supplying power to the DRP Host, which is acting as a Sink (known as the old Sink). After FRS, the Host DRP is a 5-V Source (known as the new Source, old Sink), and is supplying power to the Hub DRP configured as a Sink (known as the new Sink, old Source).

8.4.7.2 Fast Role Swap Use Cases

When the TPS6602x is used on the Host side, prior to a FRS event, the PD Controller power role is the Sink (old Sink). Since the TPS6602x only supports Sink operation via PPHV, PPHV is configured as a Sink (old Sink) and is receiving power from VBUS. Upon fast role signaling from the Hub, the TPS6602x power role will change to a Source (new Source) via the PP5V path.

NOTE

The TPS6602x does not support a fast turn-on of the PPHV path, so it cannot be used effectively as a new Sink in a fast role condition. Fast turn-on is only possible with the PP5V (Source only path) for fast role swap scenarios.

Figure 24 shows the supported TPS6602x usage case before and after a fast role swap. The TPS6602x is used in the Host DRP. Prior to a fast role swap, PPHV is configured as a Sink (old Sink) and the PP5V path is disabled. Once a Fast Role Swap signal is requested by the PD Controller, by the transition of EN1_EN0 from 01b to 11b, the TPS6602x disables its PPHV path, waits until VBUS drops vSafe5V (maximum) and then quickly enables the PP5V path, which is now the new Source.

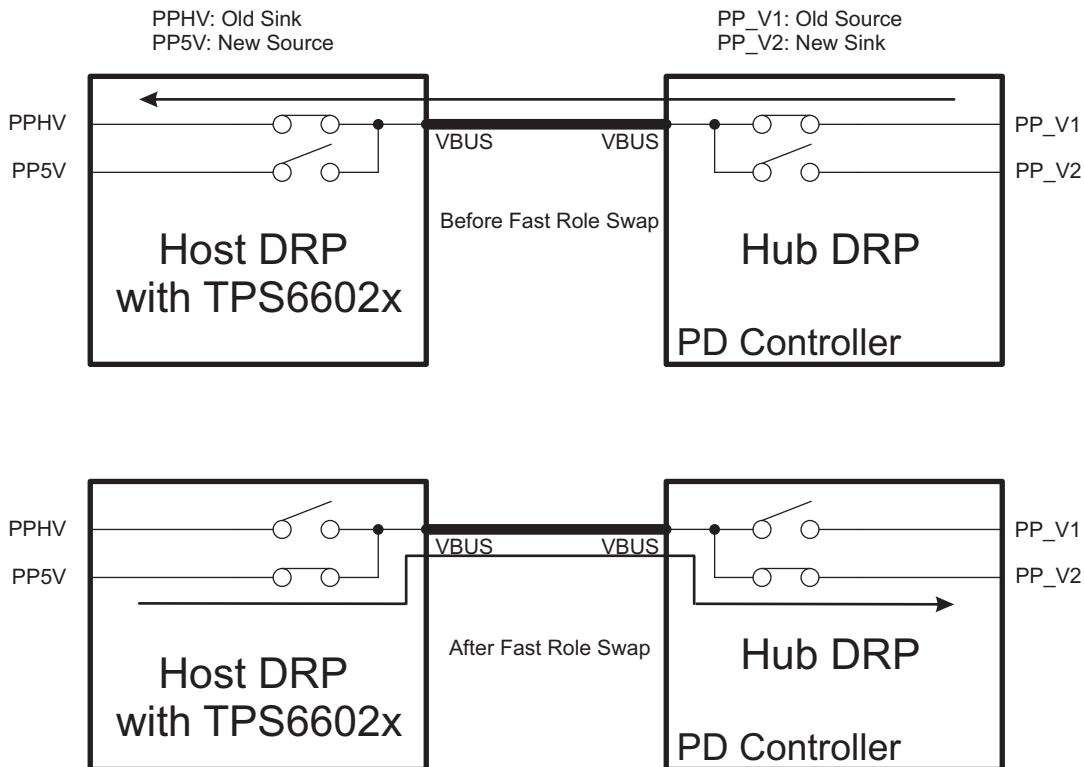


Figure 24. TPS6602x Fast Role Swap Usage Case

8.4.7.3 Fast Role Swap Sequence

The TPS6602x supports specialized hardware to minimize unnecessary delays upon a Fast Role Swap event. Figure 25 shows the fast role swap sequencing.

1. At some point, the Hub device connected to the Host detects a power loss condition and begins to transmit fast role swap signaling on its CC line to the Host PD Controller.
2. The Host PD Controller's CC detection circuitry detects fast role swap signaling applied by observing the CC line and is validated.
3. Upon validating the FRS signaling, the Host PD Controller shall assert EN1 = 1 of the TPS6602x as soon as possible to initiate the power role swap. It should be noted that since the transition of the FRS is initiated by the PD Controller, it is critical that the delay from detection of the FRS signaling to the assertion of EN1 be minimized.

4. Upon EN1 = 1 assertion, the TPS6602x PPHV path is disabled automatically by the fast role swap hardware.
5. There are two cases to consider. In Case 1, as shown in [Figure 26](#), VBUS begins to decay, while being continuously monitored by the vSafe5V comparator circuitry that indicates when VBUS has fallen below vSafe5V. Once this occurs, the comparator output is asserted indicating to the fast role swap hardware that it is safe to turn on the PP5V path, and the PP5V path is enabled automatically. In Case 2, as shown in [Figure 27](#), VBUS may have fallen below vSafe5V, or even fully discharged to ground, so the comparator output may already be asserted low. If so, the PP5V path shall be immediately enabled. It should be noted in this scenario, since the VBUS capacitance has been fully discharged, a significant in-rush current will occur when the PP5V path is enabled. Application should ensure sufficient decoupling capacitance is applied on the PP5V supply or that the supply is designed to react to fast transient responses to avoid brown-out of the supply rail.
6. PP5V is initially enabled with a higher current limit to ensure fast turn-on. Once fast role swap is completed, it reverts back to the 3-A setting. The application may then choose to stay at the 3-A setting or switch to the 1.5-A setting.

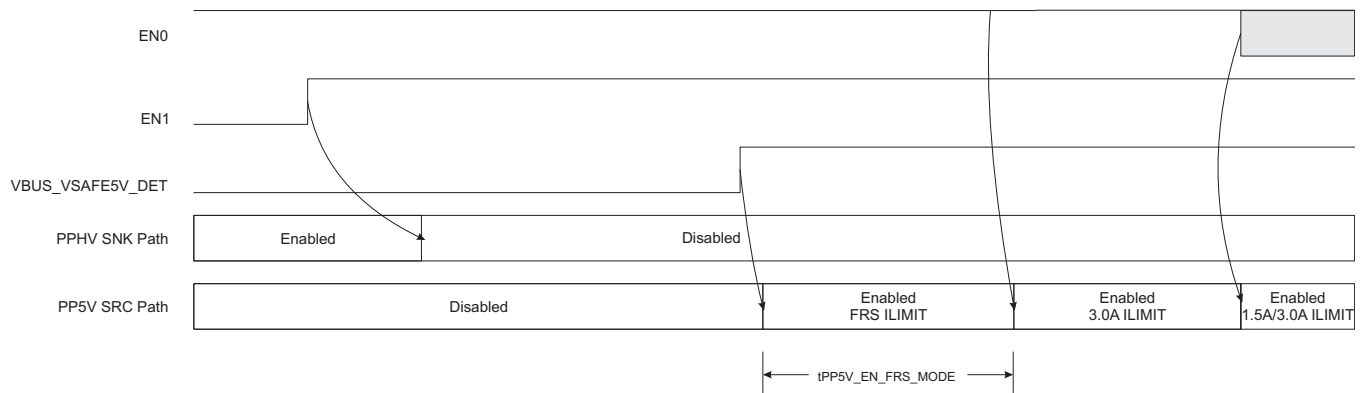


Figure 25. Fast Role Swap Timing

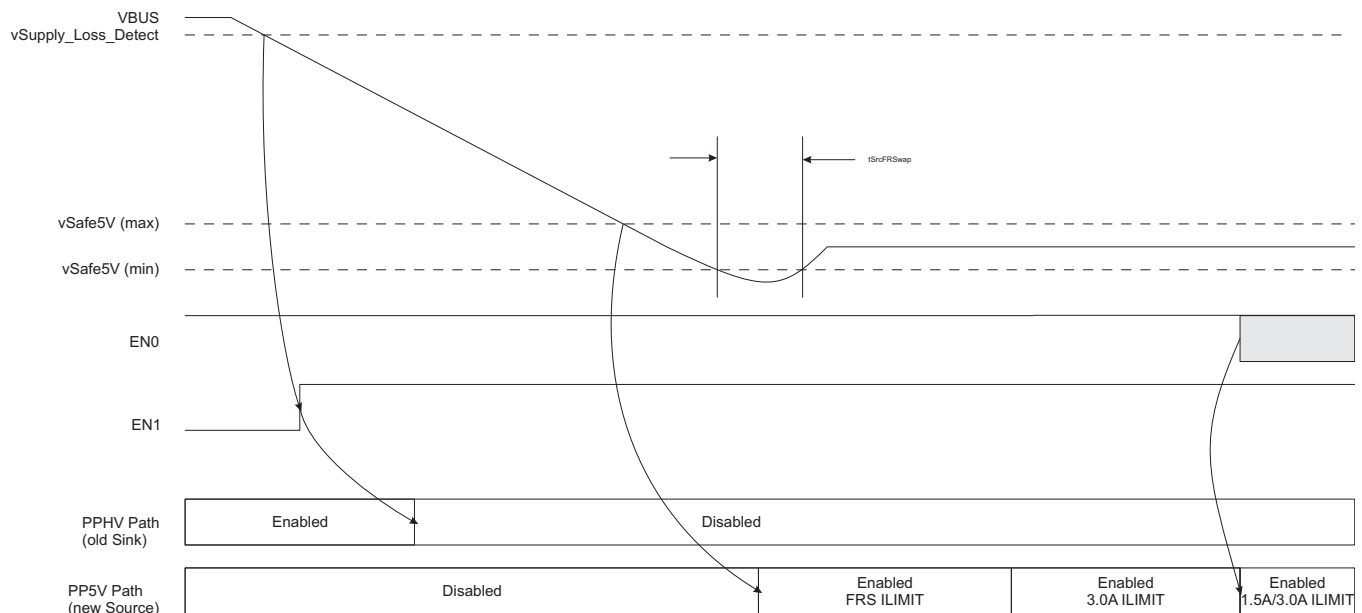


Figure 26. Fast Role Swap Events - Case 1

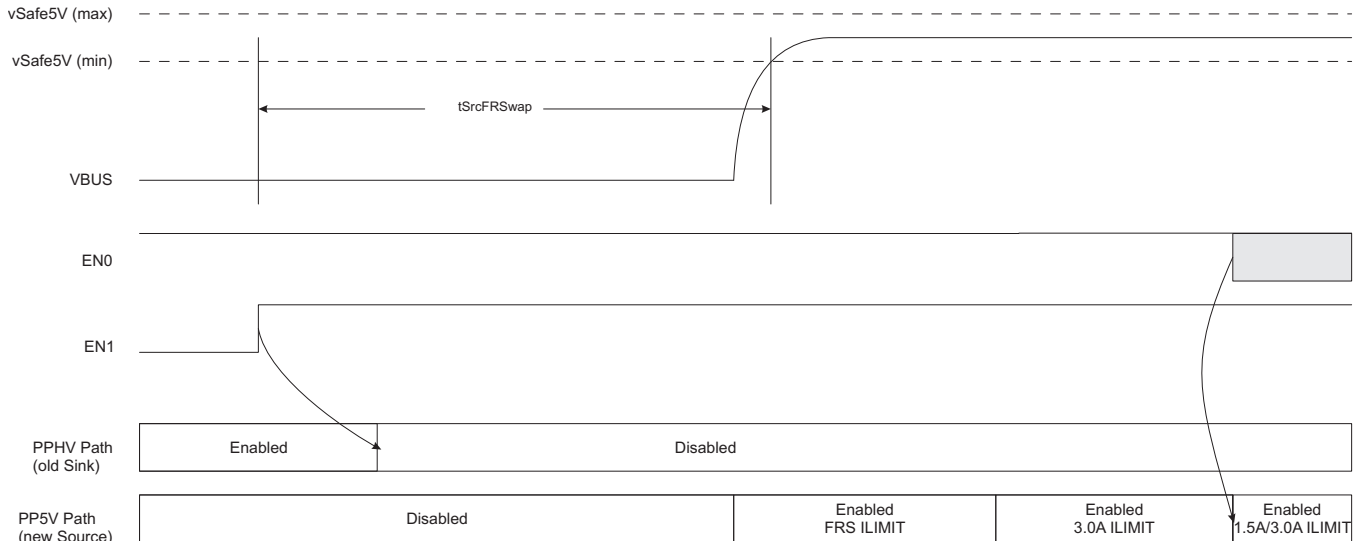


Figure 27. Fast Role Swap Events - Case 2

8.4.8 Faults

The TPS6602x includes a fault pin, $\overline{\text{FLT}}$. The $\overline{\text{FLT}}$ pin is an open-drain output and requires an external pull-up resistor. If the $\overline{\text{FLT}}$ pin is not required, it may be tied to GND or left floating. The $\overline{\text{FLT}}$ pin will be asserted low only under certain conditions and not all fault conditions will assert the $\overline{\text{FLT}}$ pin, see Table 3. If the $\overline{\text{FLT}}$ pin is asserted, it will remain asserted for a minimum of $t_{\text{HOLD_FLT}}$ regardless if the fault condition is removed. After $t_{\text{HOLD_FLT}}$, if all fault conditions have surpassed, the $\overline{\text{FLT}}$ pin is released.

8.4.8.1 Fault Types

Table 3 summarizes the various fault types available and when the $\overline{\text{FLT}}$ shall be asserted.

Table 3. Fault Types

Fault Name	Fault	$\overline{\text{FLT}}$	Description
PP5V_UVLO	PP5V undervoltage Lockout	Low	If PP5V input supply is below the PP5V UVLO threshold, the PP5V path is disabled automatically if enabled or remains disabled until the PP5V UVLO threshold is exceeded. If a SRC state is selected to be entered, the device will remain in the DISABLED state until the UVLO event is removed. The $\overline{\text{FLT}}$ pin will not be asserted. If a SRC state has been entered successfully and a UVLO event occurs, the device will enter the DISABLED state, and the $\overline{\text{FLT}}$ pin will be asserted.
PP5V_OVP	PP5V overvoltage Protection	Low	If a SRC state is selected to be entered or device currently is in a SRC state (SRC 1.5 A or SRC 3 A) and the PP5V input supply rises above the PP5V OVP threshold, the PP5V path is disabled automatically and the $\overline{\text{FLT}}$ pin will be asserted.
PP5V_ILIMIT	PP5V Current Limit Protection	Low	The PP5V power path has a closed-loop current limit protection. If the load current exceeds the selected current limit, the control loop will increase the voltage across the FET to compensate. Note: $\overline{\text{FLT}}$ will not be asserted unless the current limit event lasts longer than $t_{\text{LIMIT_FLT}}$.
PP5V_OVT	PP5V overtemperature Protection	Low	If a SRC state is selected to be entered or device currently is in a SRC state (SRC 1.5 A or SRC 3 A) and the local temperature of PP5V power path exceeds TSD_PP5V_R while in current limit, the PP5V path is disabled automatically and the $\overline{\text{FLT}}$ pin will remain asserted. PP5V power path will remain disabled until temperature falls below TSD_PP5V_F.

Table 3. Fault Types (continued)

Fault Name	Fault	$\overline{\text{FLT}}$	Description
PP5V_RCP	PP5V Reverse-Current Protection	Low	If a SRC state is selected to be entered or device currently is in a SRC state (SRC 1.5 A or SRC 3 A) and a reverse-current condition is detected, the PP5V path is disabled automatically and the FLT pin will be asserted. If the reverse-current condition is removed, the PP5V path will automatically re-enable.
VBUS_UVLO	VBUS undervoltage Lockout	Hi-Z	If VBUS supply is below the VBUS UVLO threshold, the PPHV path is disabled automatically if enabled or remains disabled. If the SNK state is selected to be entered, the device will remain in the DISABLED state until the UVLO event is removed. If the SNK state has been entered successfully and a UVLO event occurs, the PPHV path is disabled automatically.
VBUS_OVP ⁽¹⁾	VBUS overvoltage Protection	Low	If the SNK state is selected to be entered or device currently is in the SNK state and the VBUS supply rises above the VBUS OVP threshold, the PPHV path is disabled automatically and the FLT pin will be asserted.
VBUS_RCP	VBUS Reverse-Current Protection	Hi-Z	If the SNK state is selected to be entered or device currently is in the SNK state and a reverse-current condition is detected, the PPHV path is disabled automatically, but the FLT is not asserted. If the reverse-current condition is removed, the PPHV path will automatically re-enable.
PPHV_OVT	PPHV overtemperature Protection	Low	If the SNK state is selected to be entered or device currently is in the SNK state and the local temperature of PPHV power path exceeds TSD_PPHV_R, the PPHV path is disabled automatically and the FLT pin will be asserted. PPHV power path will remain disabled until temperature falls below TSD_PPHV_F.

(1) OVP terminal is not connected to GND.

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The typical applications of the TPS6602x include chargers, notebooks, tablets, ultra-books, dongles and any other product supporting USB Type-C and/or USB-PD as a power source or power sink. The typical applications outlined in the following sections detail a Fully-Featured USB Type-C using a single 5-V supply and another using a separate 3.3-V supply.

9.2 Typical Application

Figure 28 shows a USB Type-C single port design using a Power Delivery (PD) controller that supports 5-V operation. For this system, a single 5-V supply is used to supply power to the PP5V and VIN supplies of the TPS66021, as well as, the connector power, VCONN. The TPS66021 supplies power to the 5-V supply of the PD controller via its VLDO output which is sourced either from the integrated 5-V VBUS LDO for dead battery operation or from VIN once the dead battery condition ends.

Similarly, [Figure 29](#) shows a USB Type-C single port design using a PD controller that only supports 3.3-V operation. In this case, a separate 3.3-V supply in the system is used to supply power to the TPS66020. The TPS66020 supplies power to the 3.3-V supply of the PD controller via its VLDO output which is sourced either from the integrated 3.3-V VBUS LDO for dead battery operation or from VIN once the dead battery condition ends.

The PP5V integrated power path is used to provide 5-V VBUS power when the device is enabled as Source. The PPHV integrated power path provides power to the system and battery charger from VBUS when the device is enabled as a Sink.

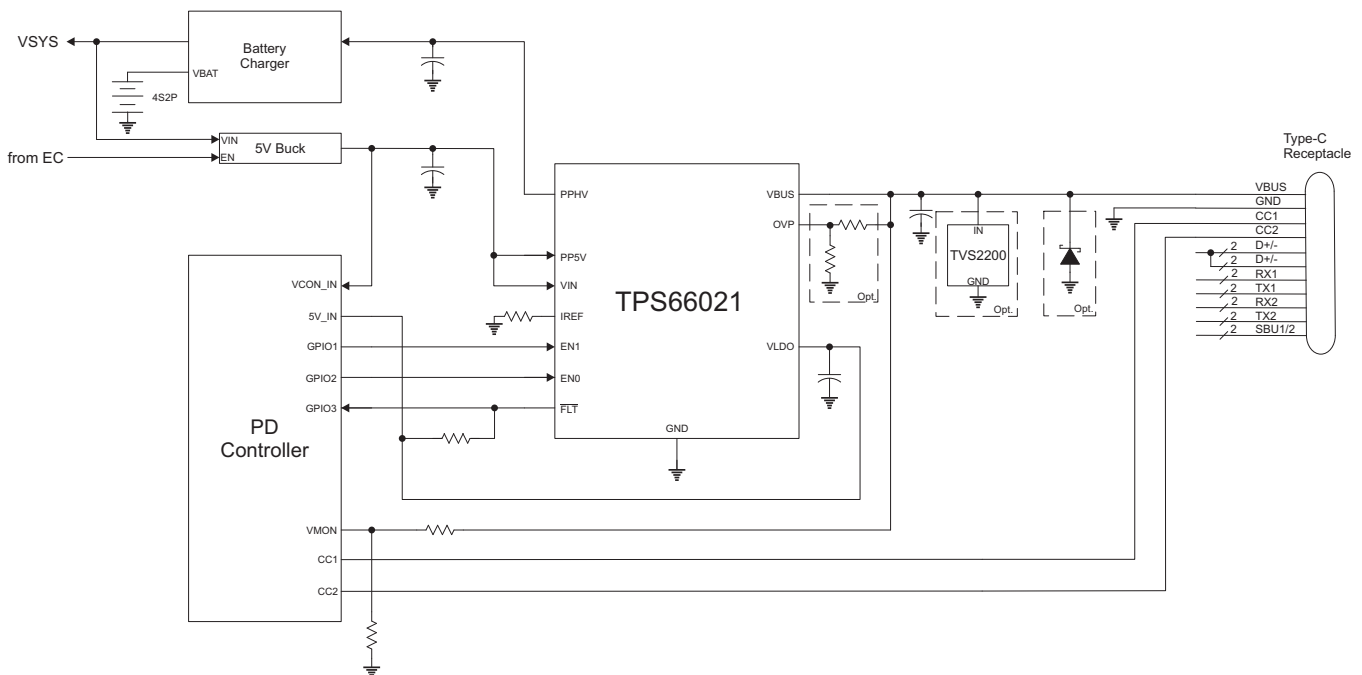


Figure 28. Single Port Type-C PD Port Using a Single 5-V Supply

Figure 29. Single Port Type-C PD Port Using a 3.3-V Supply

For a single port notebook application, Table 4 lists the input voltage requirements and expected current capabilities.

DESIGN PARAMETERS	EXAMPLE VALUE(S)	POWER PATH DIRECTION
PP5V Input Voltage and Current Capabilities	5V/3A	Source from PP5V to VBUS
VCON_IN Input Voltage and Current Capabilities	5V/300mA (1.5W)	Source to VCONN
VBUS Input Voltage and Current Capabilities	5V/3A, 9V/3A, 15V/3A, 20V/3A	Sink from VBUS to PPHV
5V_IN Input Voltage and Current Capabilities	4.5-5.5V/30mA	5-V PD Controller Supply
3V_IN Input Voltage and Current Capabilities	3.0-3.6V/30mA	3.3-V PD Controller Supply

9.2.2.1 External Current Reference Resistor (R_{IREF})

A 75-k Ω resistor is required from the TPS6602x IREF terminal to ground. R_{IREF} is used to set the proper reference current required to meet the min/max current limit specifications in the datasheet of the PP5V power path. An overall resistance tolerance of +/- 1% is required to meet the datasheet specifications which includes aging, temperature, and resistance variation. A +/- 0.5% resistor is recommended. Care should be taken to ensure the ground return of R_{IREF} is in close proximity to the GND terminal of the TPS6602x to minimize error in the current limit setting due to voltage drops that may occur across the ground supply.

9.2.2.2 External VLDO Capacitor (CVLDO)

For all capacitances, the DC operating voltage must be factored into the derating of ceramic capacitors. Generally, the effective capacitance is 35-50% of the nominal capacitance with voltage applied. Assuming VLDO = 5 V, and a minimum derated capacitance of 2.5 μ F, a 10-V rated 4.7- μ F capacitor is sufficient.

9.2.2.3 PP5V Power Path Capacitance

For most systems, the PP5V terminal is supplied by a DC-DC converter. Typically, the capacitance placed on the output of the DC-DC converter is significant in order to handle current load steps. This capacitance value will be dependent on the DC-DC converter selected. A ceramic 10 μ F (X7R/X5R) 10-V rated capacitor coupled with a 0.1- μ F high frequency capacitor placed, is placed as close as possible to the PP5V terminal of the TPS6602x. This is in addition to the DC-DC converter required capacitance should be sufficient, but may need to be adjusted based on the specific application.

It should be noted that in many Type-C/PD systems, the VCONN supply is shared with the PP5V path. Therefore, in these systems, the application must budget the power requirements of the DC-DC converter for the VCONN and PP5V paths combined. For this example, a minimum of 5 V at 3.3 A is required to meet the defined system specifications.

9.2.2.4 PPHV, VBUS Power Path Capacitance

The PPHV power path is a Sink. The capacitance on the PPHV shown in [Figure 29](#) represents capacitance of the charger sub-system. In a typical application, this capacitance can be in the range of 47 μ F up to 100 μ F, far exceeding the 1- μ F minimum specification for the TPS6602x, so no external capacitance is required to meet this requirement in most cases. As per the PD Specification, the total capacitance on VBUS should be maximum 10 μ F at connection.

The TPS6602x PPHV power path has soft start circuitry to control in-rush current when the PPHV power path is enabled. DC loading should be minimized during soft start since the PPHV path may experience high power dissipation especially at higher VBUS voltages. This in turn may lead to a PPHV overtemperature protection event.

9.2.2.5 VBUS TVS Protection (Optional)

It is recommended that each VBUS port in the system have TVS protection to protect the VBUS terminal. Inductive ringing during momentary disconnects and reconnects due to mechanical vibration or plug removal while sinking large current loads may cause large peak voltages to be present on the VBUS terminal that may exceed the absolute maximums of the TPS6602x. Under such events, the TVS2200 clamps the VBUS terminal and prevents VBUS from exceeding the maximum specification. The TVS trip point should be chosen to be safely above the normal operating ranges of the device. For this case, it is assumed VBUS voltage contracts are less than 22-V maximum which is below the minimum breakdown voltage of the TVS2200. The maximum clamping voltage of 28.3 V of the TVS2200 is sufficient to protect the VBUS terminal of the TPS6602x.

9.2.2.6 VBUS Schottky Diode Protection (Optional)

To prevent the possibility of large ground currents into the TPS6602x during sudden disconnects because of inductive effects in a cable, it is recommended that a Schottky diode be placed from VBUS to GND. The NSR20F30NXT5G or comparable device is recommended.

9.2.2.7 VBUS Overvoltage Protection (Optional)

VBUS Overvoltage Protection (OVP) is optional. If VBUS OVP is not required, then the OVP terminal should be tied to ground as shown in [Figure 12](#). VBUS OVP is used to detect voltages on VBUS that exceed a set threshold. Upon detection, the PPHV power path is disabled quickly to help protect components connected downstream of the PPHV terminal. It should be noted that VBUS OVP is not a replacement for VBUS TVS protection which is protecting the VBUS terminal itself.

The VBUS OVP threshold is set by a resistor divider from the VBUS terminal to ground as shown in [Figure 11](#). For this design, R1 and R2 are fixed values to provide VBUS OVP protection at the highest voltage contract level. Using R1 = 432-k Ω and R2 = 20-k Ω sets a nominal VBUS OVP threshold of 22.6 V. For some applications, it may be desirable to dynamically change the VBUS OVP level based on the negotiated power contract. One possible way is shown in [Figure 13](#). In this case, the PD controller via GPIO, selects the proper divider ratio to set the VBUS OVP threshold based on the negotiated voltage contract level.

9.2.2.8 Dead Battery Support

The TPS6602x integrates a high-voltage VBUS LDO that can be used to supply power to a PD Controller and other supporting circuitry when only VBUS power is available, such as in a dead battery condition. As shown in [Figure 29](#), the TPS66020 VLDO output supplies power to the PD Controller's 3V_IN supply. Similarly, [Figure 28](#) shows the TPS66021 VLDO output supplies power to the PD Controller's 5V_IN supply. During a dead battery condition, the PD Controller presents its Type-C RPD pull-downs on the CC1 and CC2 lines. Upon connection to a Type-C/PD Source, 5 V is provided to VBUS from the Source partner which powers the TPS6602x. The VBUS LDO is enabled and provides power to the PD Controller. Once powered, the PD Controller can decide to enable the TPS6602x PPHV Sink path by asserting EN0 high and use the 5-V VBUS to charge the battery or it may choose to negotiate a higher voltage contract first. Either way, once the contract is negotiated, the PD Controller will enable the PPHV Sink path and charge the system. Once the system is sufficiently charged, the VIN terminal will rise and will exceed the VIN UVLO threshold. If VIN remains above the UVLO threshold for t_{VIN_STABLE} , VLDO will be supplied from VIN and the VBUS LDO will be disabled.

9.2.2.9 Fast Role Swap (FRS) (Optional)

The TPS6602x supports Fast Role Swap operation as in the new Source, old Sink scenario shown in [Figure 24](#). The PPHV power path represents the old Sink and the PP5V power path represents the new Source. During FRS, the PP5V power path of the TPS6602x has a much faster turn-on compared to normal operation, for example entering SRC 1P5A or SRC 3P0A states from the DISABLED state. This faster turn-on is required in order to meet the USB PD fast role swap timing requirements (t_{SrcFRS}) for the new Source.

To enable FRS, the TPS6602x must first be operating as a Sink (SNK state). The TPS6602x must then transition to the FRS state by asserting EN1 high. EN1 is asserted high by the PD Controller as soon as possible once it has properly detected FRS signaling from its port partner on its CC line. The FRS signaling from the port partner to the PD Controller indicates that the port partner has lost its power and requires a fast role swap sequence to be performed.

It should be noted that the timing of when EN1 is asserted high relative to the port partner losing power is highly application, and implementation dependent. Some of these dependencies include:

- Loss of power detection accuracy, margin and propagation delay of the port partner.
- Timing from loss of power detection to FRS signaling transmitted on the CC line.
- Detection by the PD Controller of the FRS signaling received on its CC line.
- Assertion of a GPIO from the PD Controller after detection of the FRS signaling.

In systems that require good FRS performance, these should be optimized to minimize unnecessary delays from significantly impacting the turn-on of the new Source. Once the FRS state is entered, the TPS6602x will automatically handle the power role swap from Sink to Source as shown in [Figure 25](#). In most applications, there is significant charge being stored in reserve while power is being provided. Upon loss of power, this charge is then used to supply power to the application until the FRS completes. As this charge depletes, the voltage on VBUS will decay at some rate based on the current load and the amount of charge that has been stored. USB PD requires that the new Source only be enabled once VBUS is detected below v_{Safe5V} (maximum). Therefore, the amount of voltage that VBUS drops below v_{Safe5V} will depend heavily on the amount of remaining charge and what current load is on VBUS, along with how fast the PP5V power path can enable. It should be noted that the PD Specification allows VBUS to be discharged completely to ground and is shown in [Figure 32](#) typical response curve.

9.2.3 Application Curves

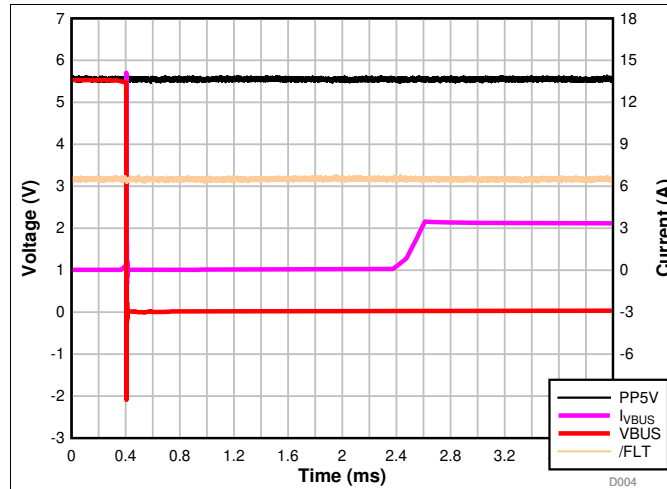


Figure 30. PP5V Current Limit Response

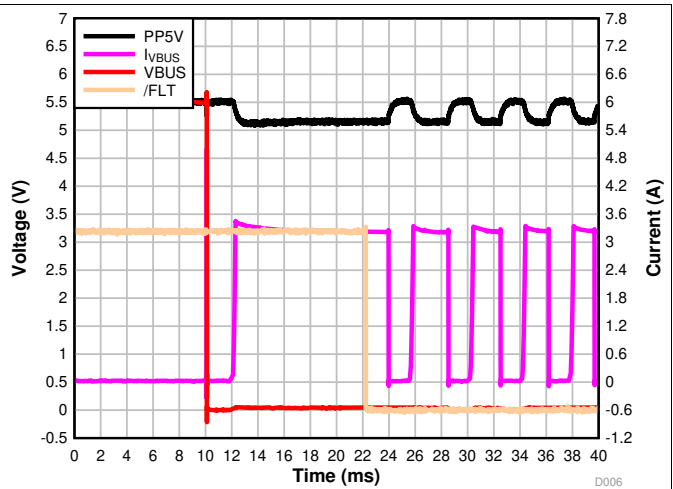


Figure 31. PP5V Enable into Short with Thermal Cycling

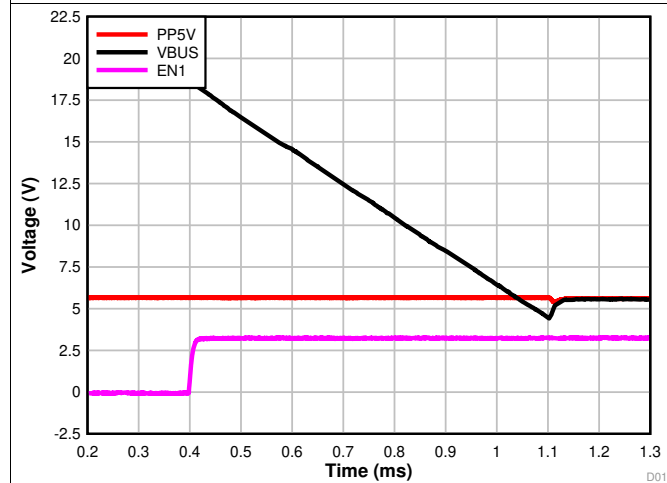


Figure 32. Fast Role Swap Response, 20-V Sink Contract,
 $C_{VBUS} = 20 \mu F$, $I_{VBUS} = 0.5 A$

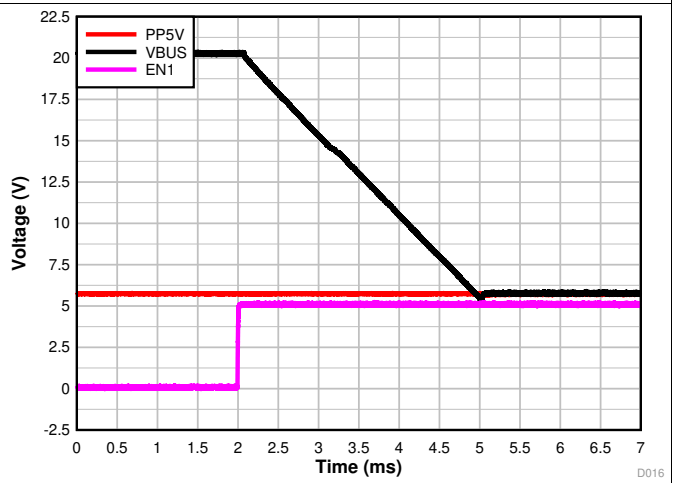


Figure 33. Fast Role Swap Response, 20-V Sink Contract,
 $C_{VBUS} = 120 \mu F$, $I_{VBUS} = 0.5 A$

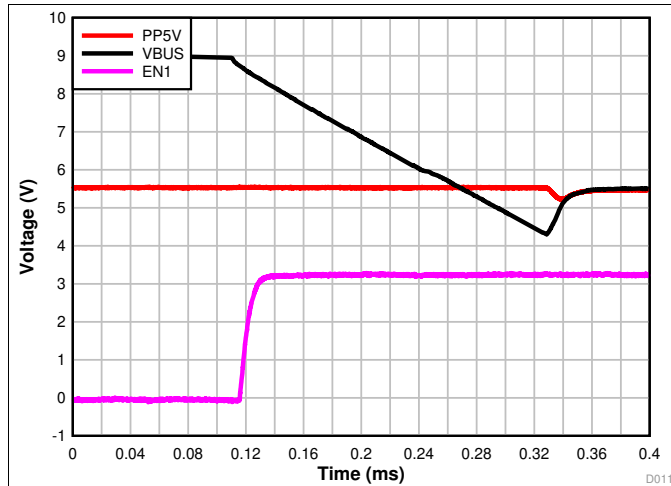


Figure 34. Fast Role Swap Response, 9-V Sink Contract,
 $C_{VBUS} = 20 \mu F$, $I_{VBUS} = 0.5 A$

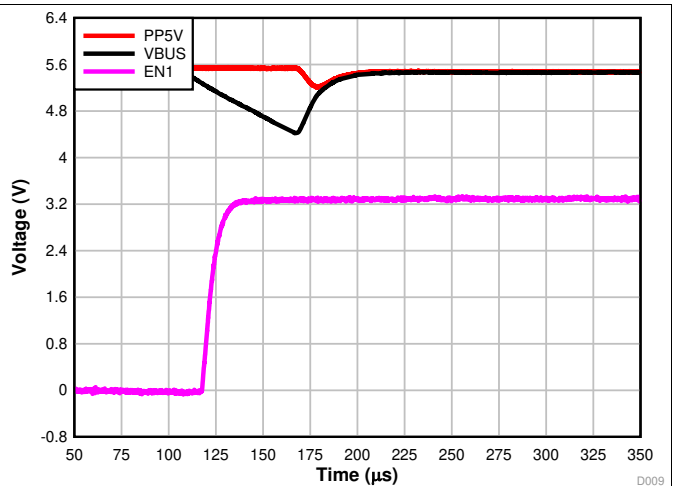


Figure 35. Fast Role Swap Response, 5-V Sink Contract,
 $C_{VBUS} = 20 \mu F$, $I_{VBUS} = 0.5 A$

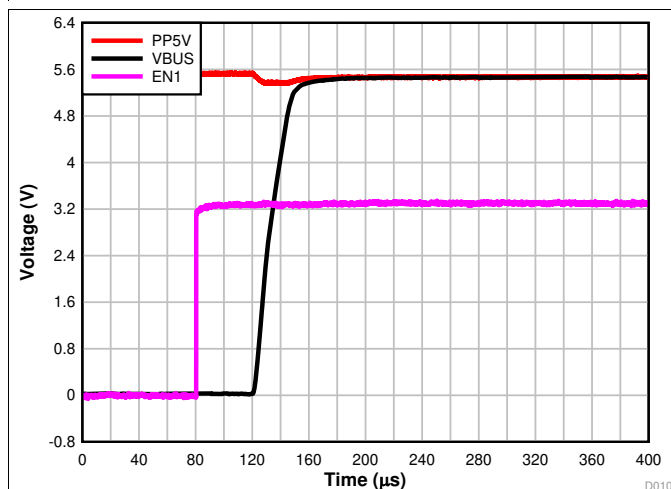


Figure 36. Fast Role Swap Response, 5-V Sink Contract,
VBUS Fully Discharged, $C_{VBUS} = 20 \mu F$, $I_{VBUS} = 0.5 A$

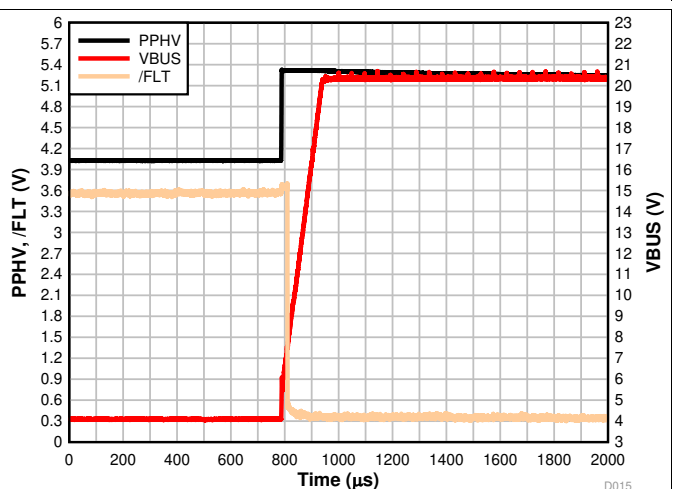


Figure 37. VBUS OVP Response with 6-V Threshold

10 Power Supply Recommendations

The device has a single input supply, VIN. VIN may be shared with PP5V when using the TPS66021 device. When shared with PP5V, the capacitance required on PP5V is sufficient for the VIN supply. When VIN is not shared, a 1-μF or higher ceramic bypass capacitor between VIN and GND is recommended as close to the VIN as possible for local noise decoupling.

USB Specification Revisions 2.0 and 3.1 require VBUS voltage at the connector to be between 4.75 V to 5.5 V. Depending on layout and routing from supply to the connector the voltage droop on VBUS has to be tightly controlled. Locate the input supply close to the device. For all applications, a maximum 10-μF ceramic bypass capacitor between VBUS and GND is recommended as close to the Type-C connector of the device as possible for local noise decoupling. The input power supply should be rated higher than the current limit set to avoid voltage droops during overcurrent and short-circuit conditions.

11 Layout

11.1 Layout Guidelines

1. PP5V, PPHV, and VBUS traces must be as short and wide as possible to accommodate for high currents.
2. A ceramic 10 uF (X7R/X5R) 10-V rated capacitor coupled with a 0.1-uF high frequency capacitor placed, is placed as close as possible to the PP5V terminal of the TPS6602x.
3. Care should be taken to ensure the ground return of R_{IREF} is in close proximity to the GND terminal of the TPS6602x to minimize error in the current limit setting due to voltage drops that may occur across the ground supply.
4. A ceramic 4.7 uF (X7R/X5R) 10-V rated capacitor is placed as close as possible to the VLDO terminal of the TPS6602x.

11.2 Layout Example

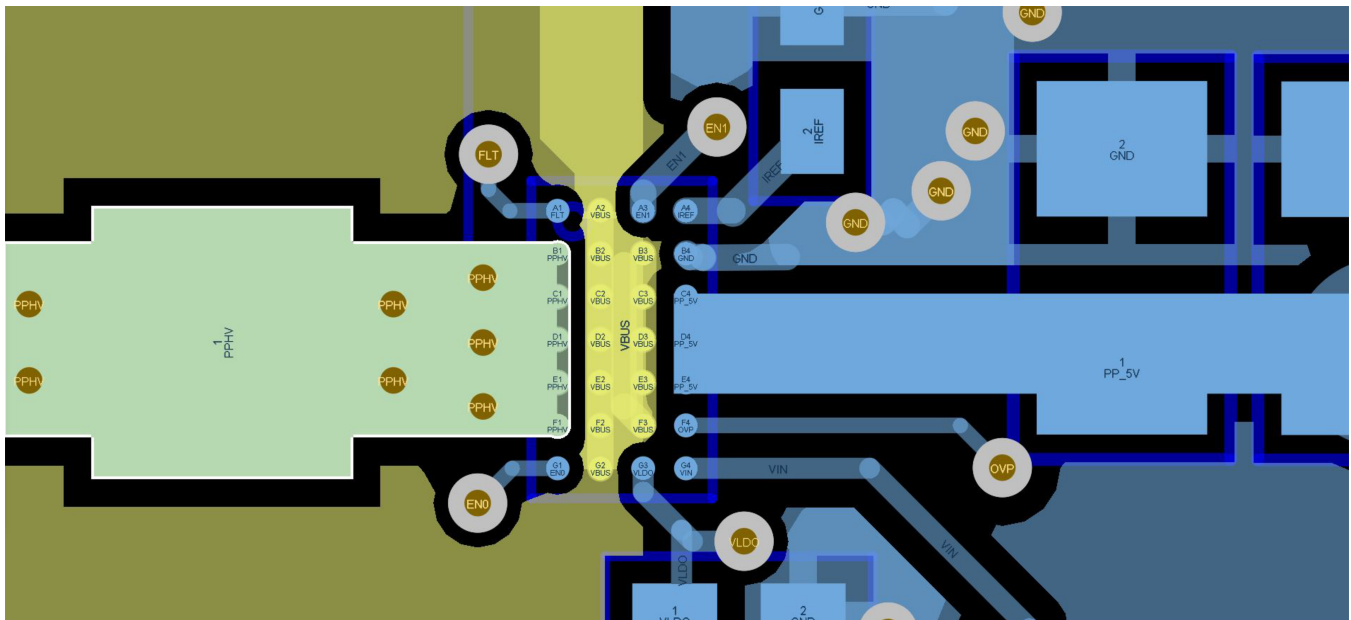


Figure 38. Layout Example

12 Device and Documentation Support

12.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to order now.

Table 5. Related Links

PARTS	PRODUCT FOLDER	ORDER NOW	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
TPS66020	Click here	Click here	Click here	Click here	Click here
TPS66021	Click here	Click here	Click here	Click here	Click here

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

12.4 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
PTPS66020A0YBGR.B	Active	Preproduction	DSBGA (YBG) 28	3000 LARGE T&R	-	Call TI	Call TI	-10 to 85	
PTPS66021A0YBGR.B	Active	Preproduction	DSBGA (YBG) 28	3000 LARGE T&R	-	Call TI	Call TI	-10 to 85	
TPS66020YBGR	Active	Production	DSBGA (YBG) 28	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-10 to 85	TPS66020
TPS66020YBGR.A	Active	Production	DSBGA (YBG) 28	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-10 to 85	TPS66020
TPS66020YBGR.B	Active	Production	DSBGA (YBG) 28	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-10 to 85	TPS66020
TPS66021YBGR	Active	Production	DSBGA (YBG) 28	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-10 to 85	TPS66021
TPS66021YBGR.A	Active	Production	DSBGA (YBG) 28	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-10 to 85	TPS66021
TPS66021YBGR.B	Active	Production	DSBGA (YBG) 28	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-10 to 85	TPS66021

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

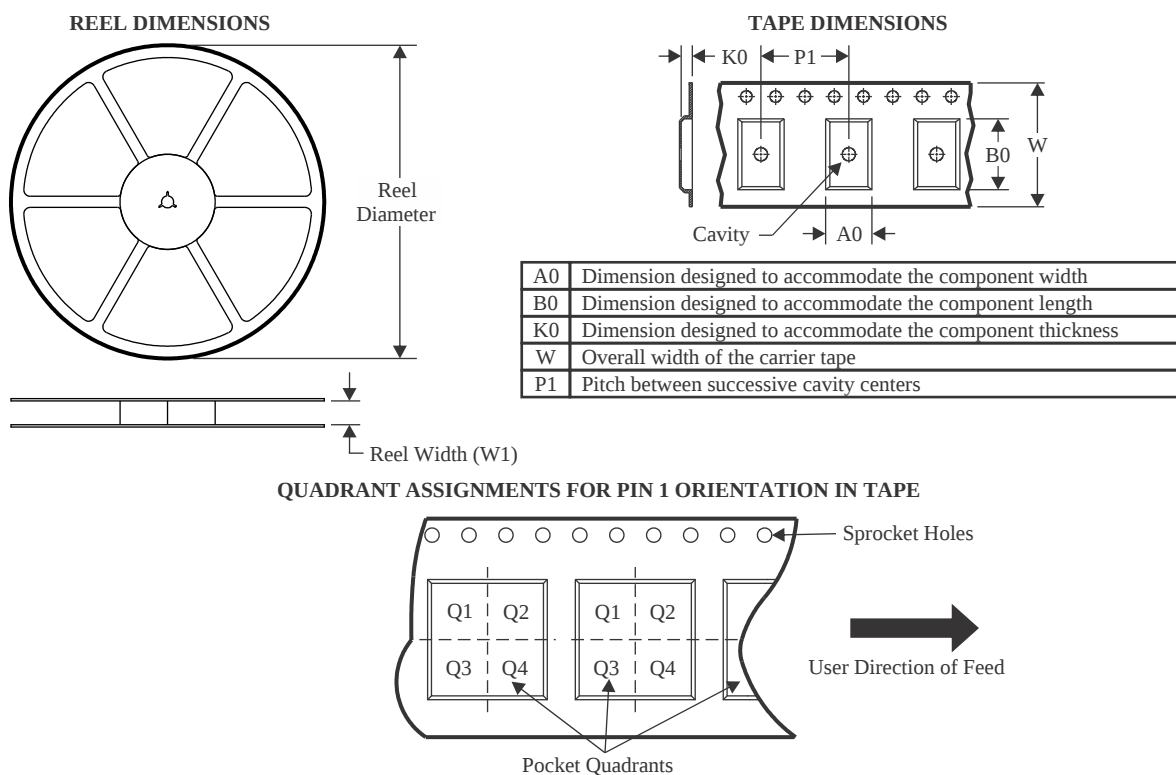
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

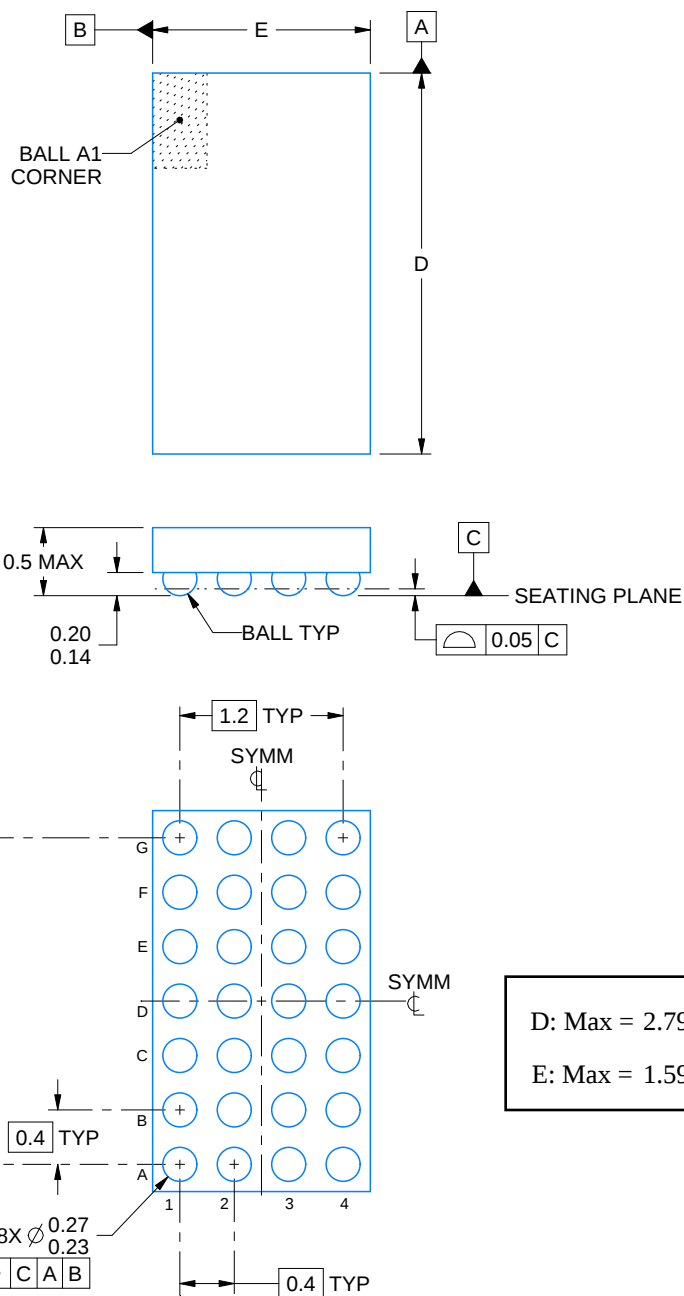
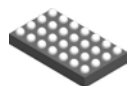
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS66020YBGR	DSBGA	YBG	28	3000	330.0	12.4	1.78	2.98	0.6	4.0	12.0	Q1
TPS66020YBGR	DSBGA	YBG	28	3000	330.0	12.4	1.78	2.98	0.7	4.0	12.0	Q1
TPS66021YBGR	DSBGA	YBG	28	3000	330.0	12.4	1.78	2.98	0.7	4.0	12.0	Q1
TPS66021YBGR	DSBGA	YBG	28	3000	330.0	12.4	1.78	2.98	0.6	4.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS66020YBGR	DSBGA	YBG	28	3000	335.0	335.0	25.0
TPS66020YBGR	DSBGA	YBG	28	3000	367.0	367.0	35.0
TPS66021YBGR	DSBGA	YBG	28	3000	367.0	367.0	35.0
TPS66021YBGR	DSBGA	YBG	28	3000	335.0	335.0	25.0



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NOTES:

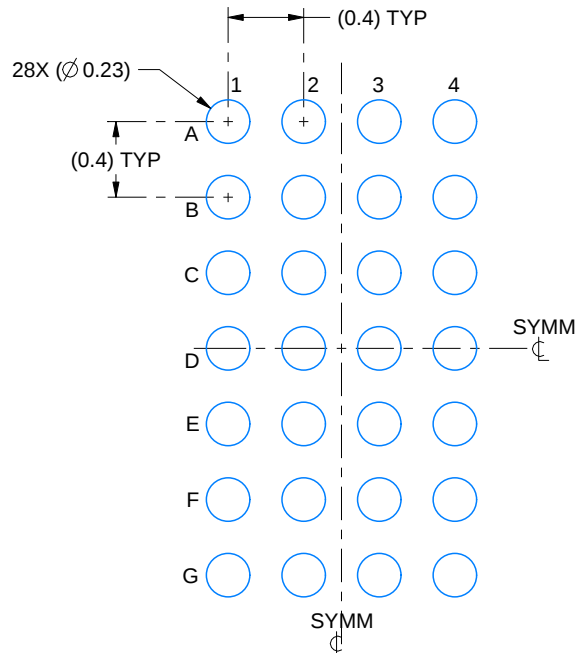
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

EXAMPLE BOARD LAYOUT

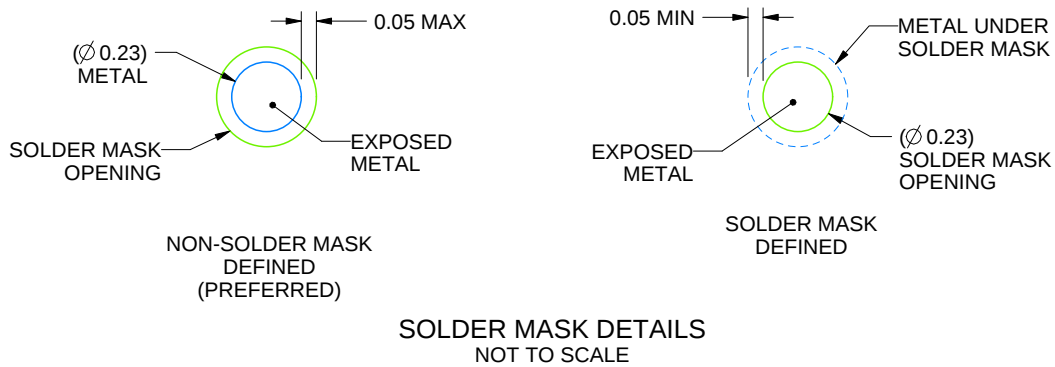
YBG0028

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 25X

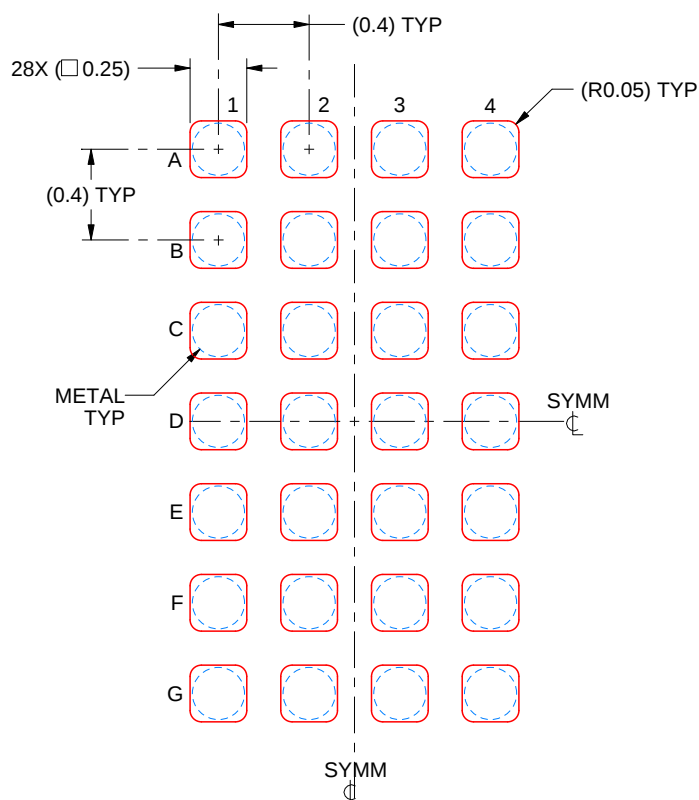


SOLDER MASK DETAILS
NOT TO SCALE

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NOTES: (continued)

- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. See Texas Instruments Literature No. SNVA009 (www.ti.com/lit/snva009).



SOLDER PASTE EXAMPLE
 BASED ON 0.1 mm THICK STENCIL
 SCALE: 30X

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NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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